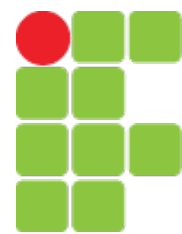


Instituto Federal de Educação, Ciência e Tecnologia de Santa Catarina

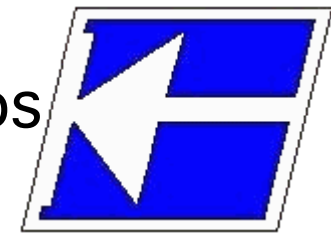


INSTITUTO FEDERAL
SANTA CATARINA

Departamento Acadêmico de Eletrônica

Pós-Graduação em Desen. de Produtos Eletrônicos

Conversores Estáticos e Fontes Chaveadas



Semicondutores, Perdas e Cálculo Térmico

Prof. Clovis Antonio Petry.

Prof. Joabel Moia.

Florianópolis, fevereiro de 2014.

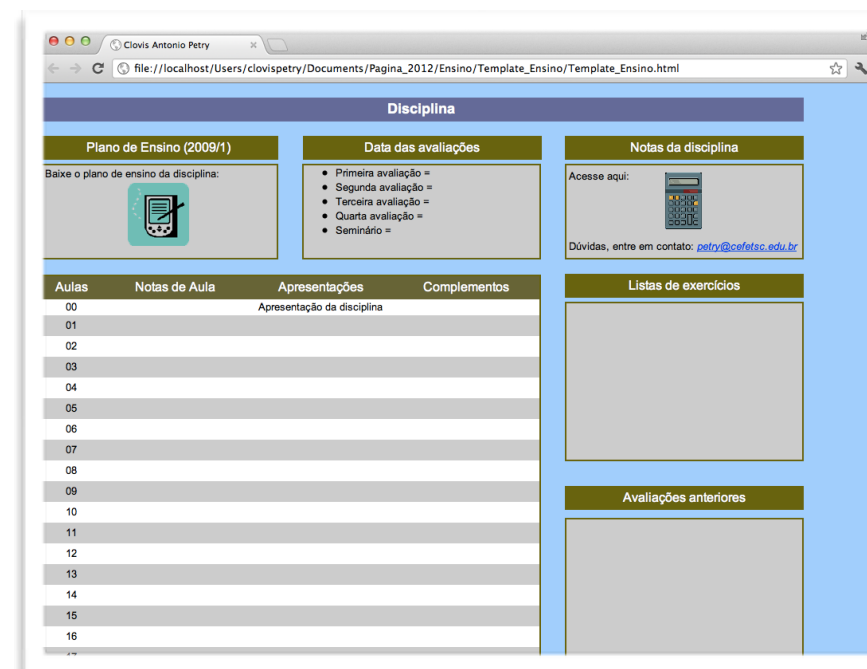
Biografia para Esta Aula

Semicondutores para eletrônica de potência:

- Semicondutores;
- Perdas;
- Cálculo térmico.



www.ProfessorPettry.com.br

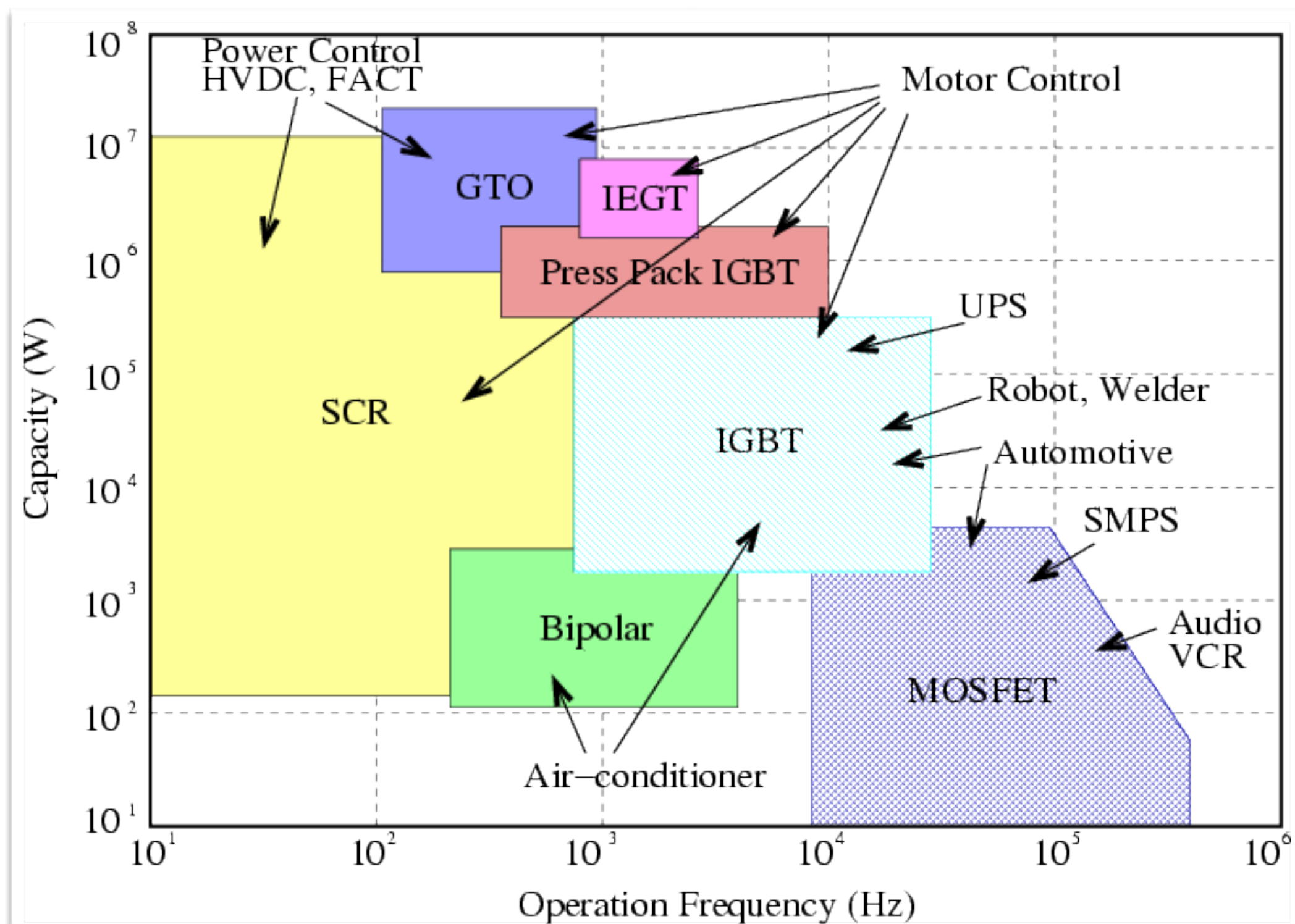


Semicondutores de potência:

- Semicondutores para eletrônica de potência;
- Diodos ideais;
- Diodos reais;
- Comutação de diodos;
- Perdas em diodos;
- Características importantes de diodos;
- Revisão de BJT;
- BJT x FET;
- FETs;
- MOSFETs;
- IGBTs;
- Cálculo térmico;
- Outros componentes importantes.

Semicondutores de Potência

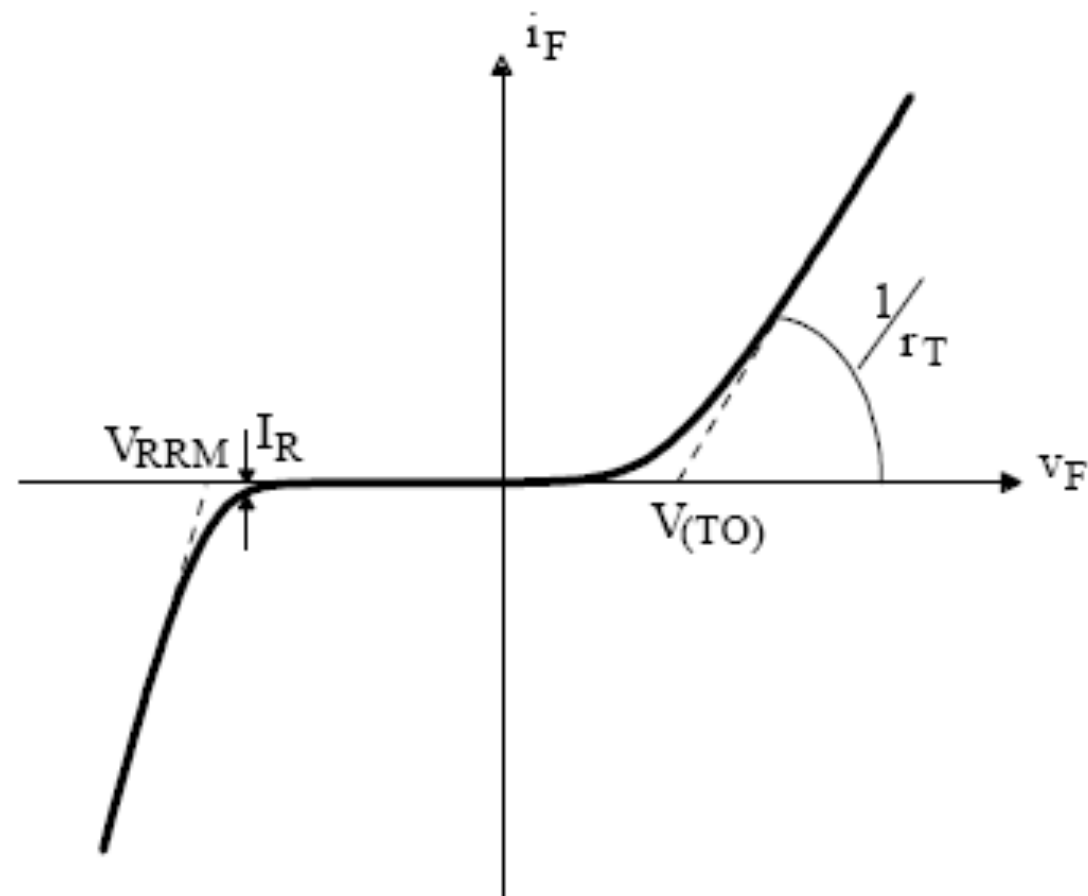
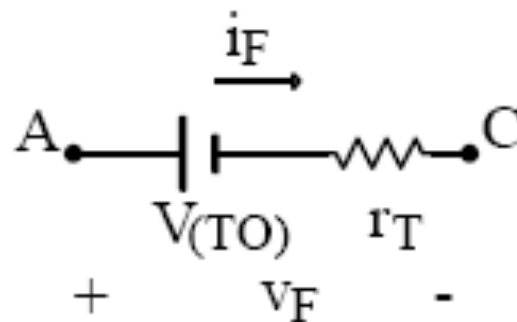
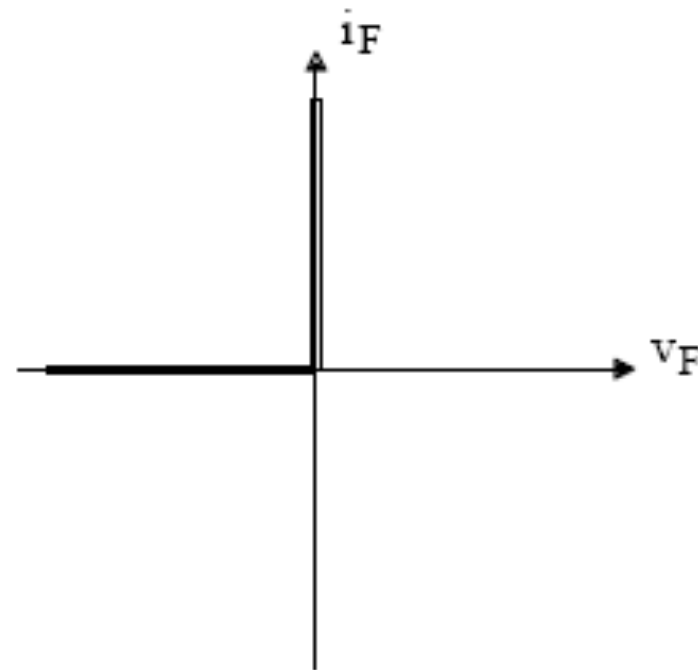
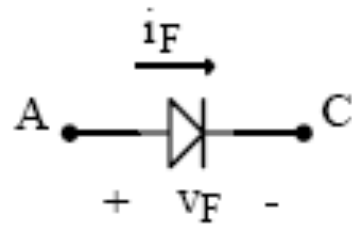
Semicondutores aplicados à eletrônica de potência:



Diodo Ideal x Diodo Real

Exemplo: Diodo SKN20/08

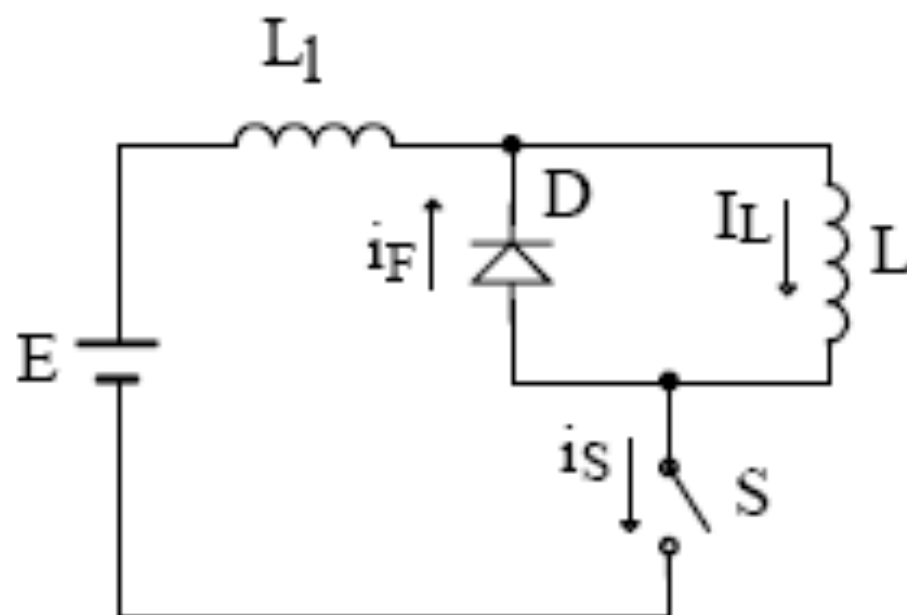
- $V_{RRM} = 800 \text{ V}$;
- $V_{(TO)} = 0,85 \text{ V}$;
- $r_T = 11 \text{ m}\Omega$;
- $I_{Dmed} = 20 \text{ A}$;
- $I_R = 0,15 \text{ mA}$.



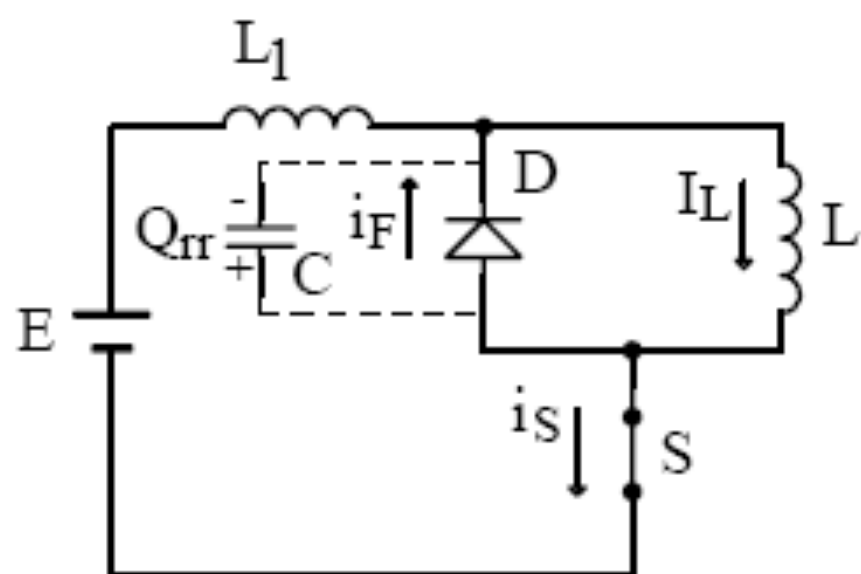
Característica estática

Comutação de Diodos

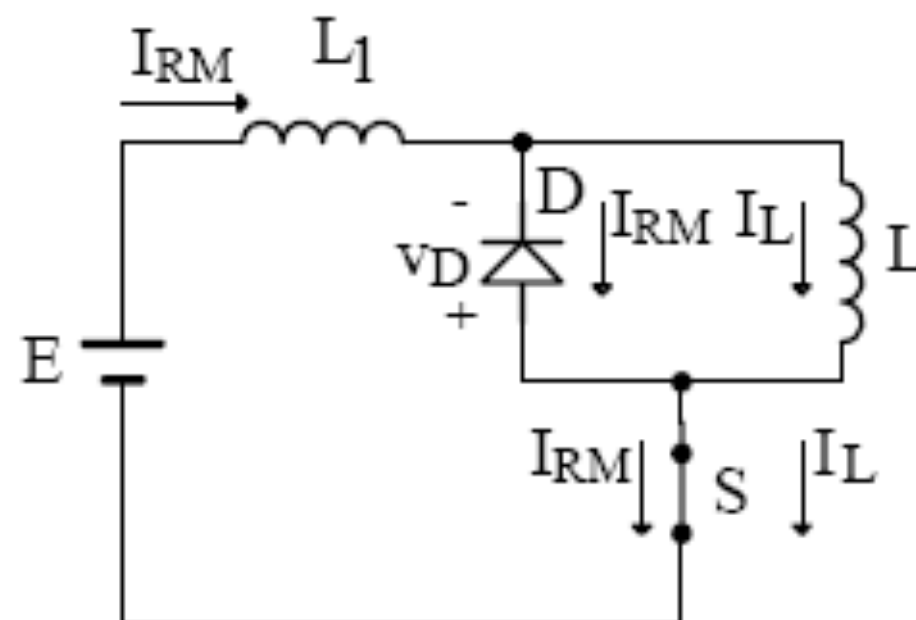
Bloqueio:



Circuito para estudo da comutação



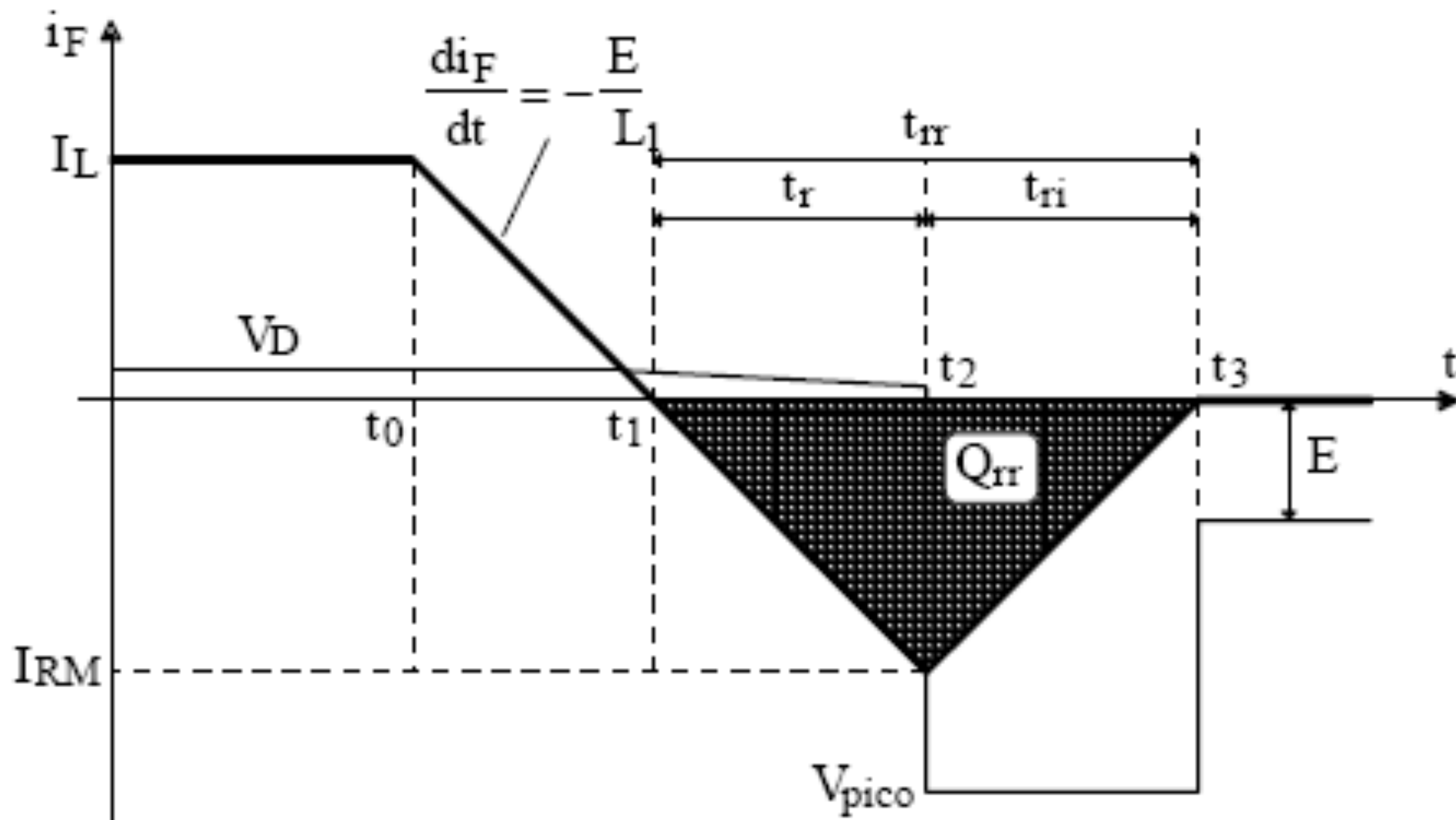
Primeira etapa de comutação



Segunda etapa de comutação

Comutação de Diodos

Bloqueio:



Comutação de Diodos

No bloqueio do diodo (comutação crítica):

$$\frac{di_F}{dt} = -\frac{E}{L_1}$$

Derivada da corrente depende da indutância

$$t_{rr} \cong \sqrt{\left(\frac{3Q_{rr}}{di_F/dt} \right)}$$

Tempo de recuperação reversa

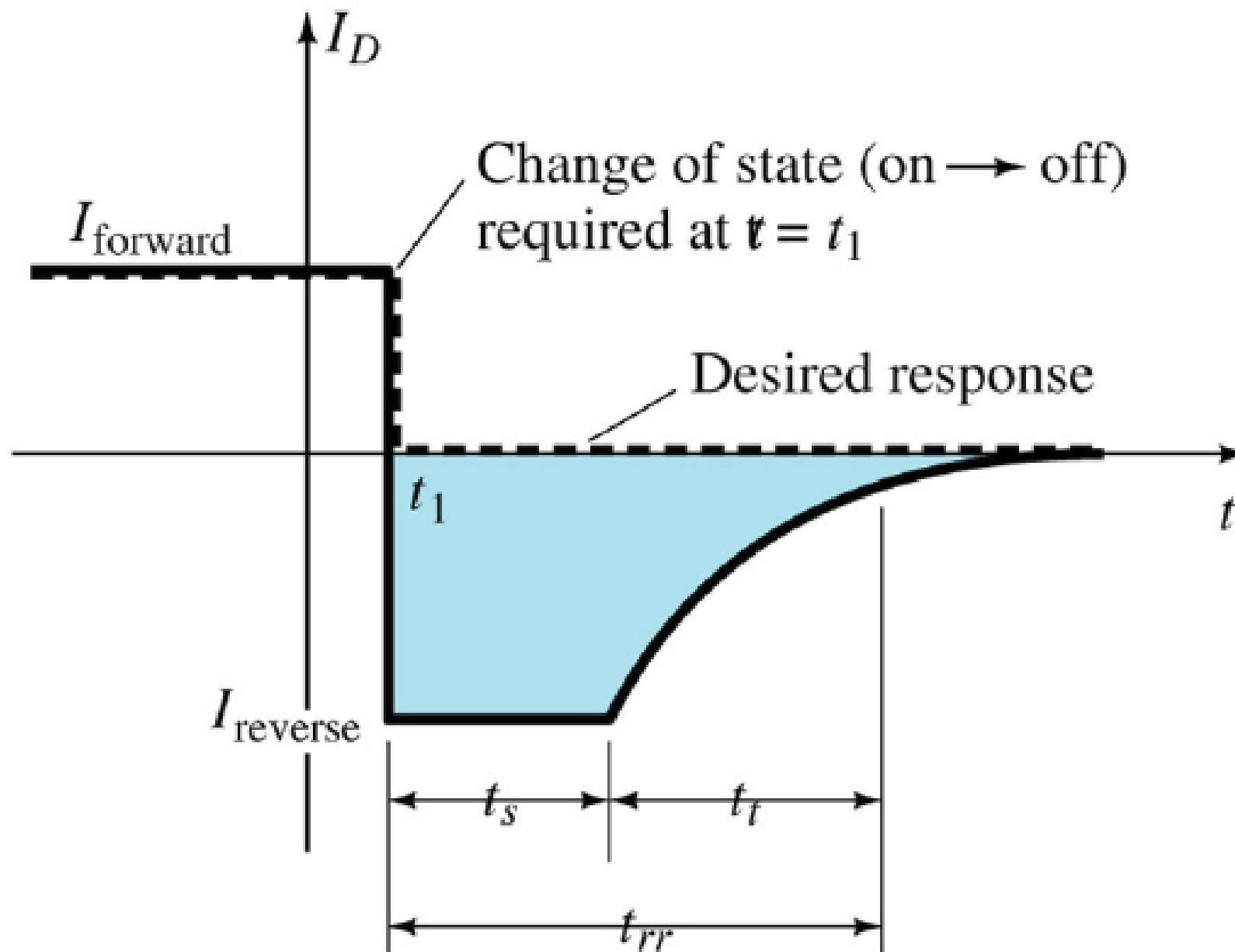
$$I_{RM} \cong \sqrt{\left(\frac{4}{3} Q_{rr} \frac{di_F}{dt} \right)}$$

Corrente máxima devido a recuperação reversa

Comutação de Diodos

Diodos de carbeto de silício (silicon carbide):

- Diminuem acentuadamente o fenômeno da recuperação reversa.



www.infineon.com

www.cree.com

Comutação de Diodos

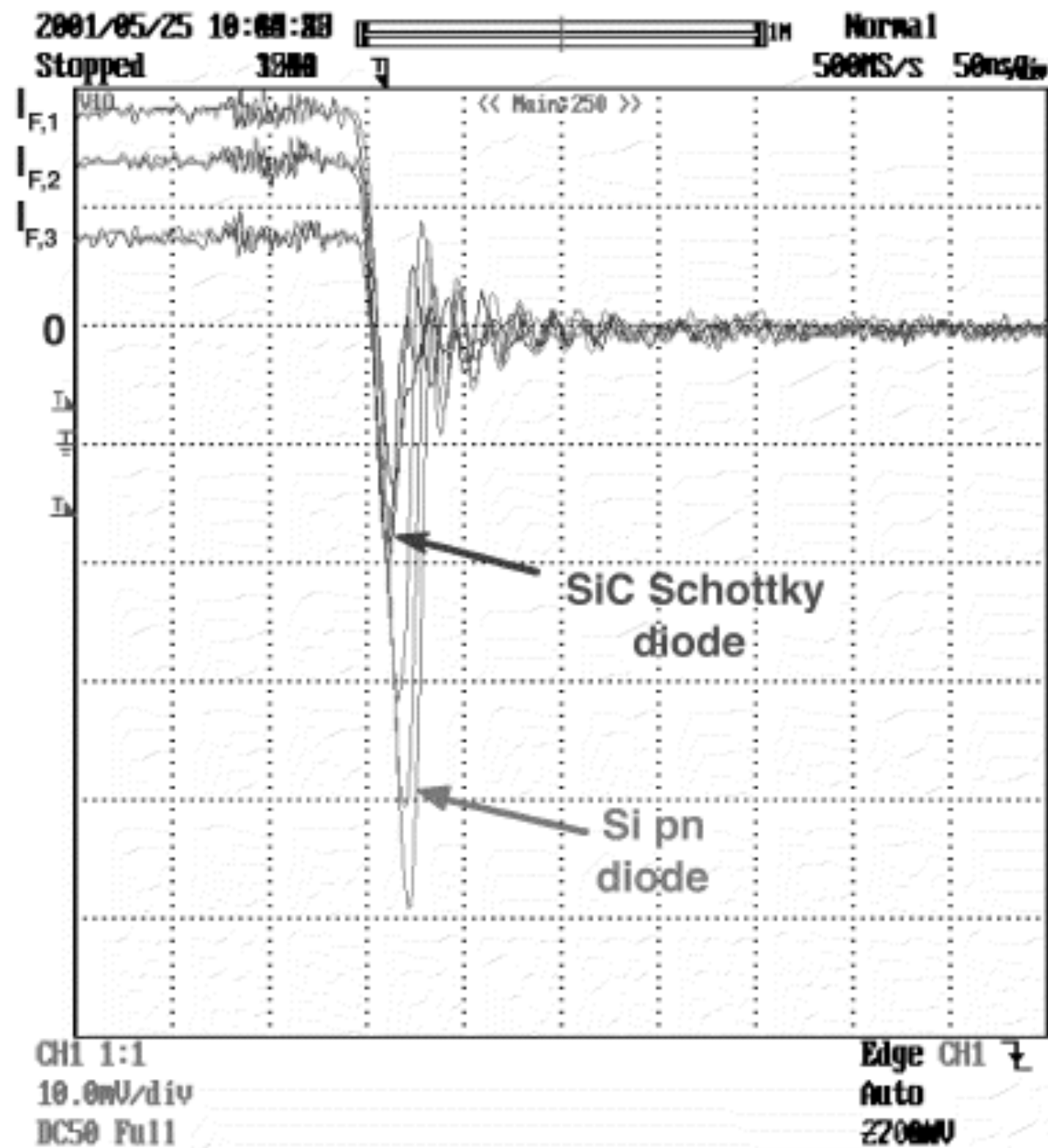


Fig. 5. Typical reverse recovery waveforms of the Si pn and SiC Schottky diode for three different forward currents (2 A/div.).

Comutação de Diodos

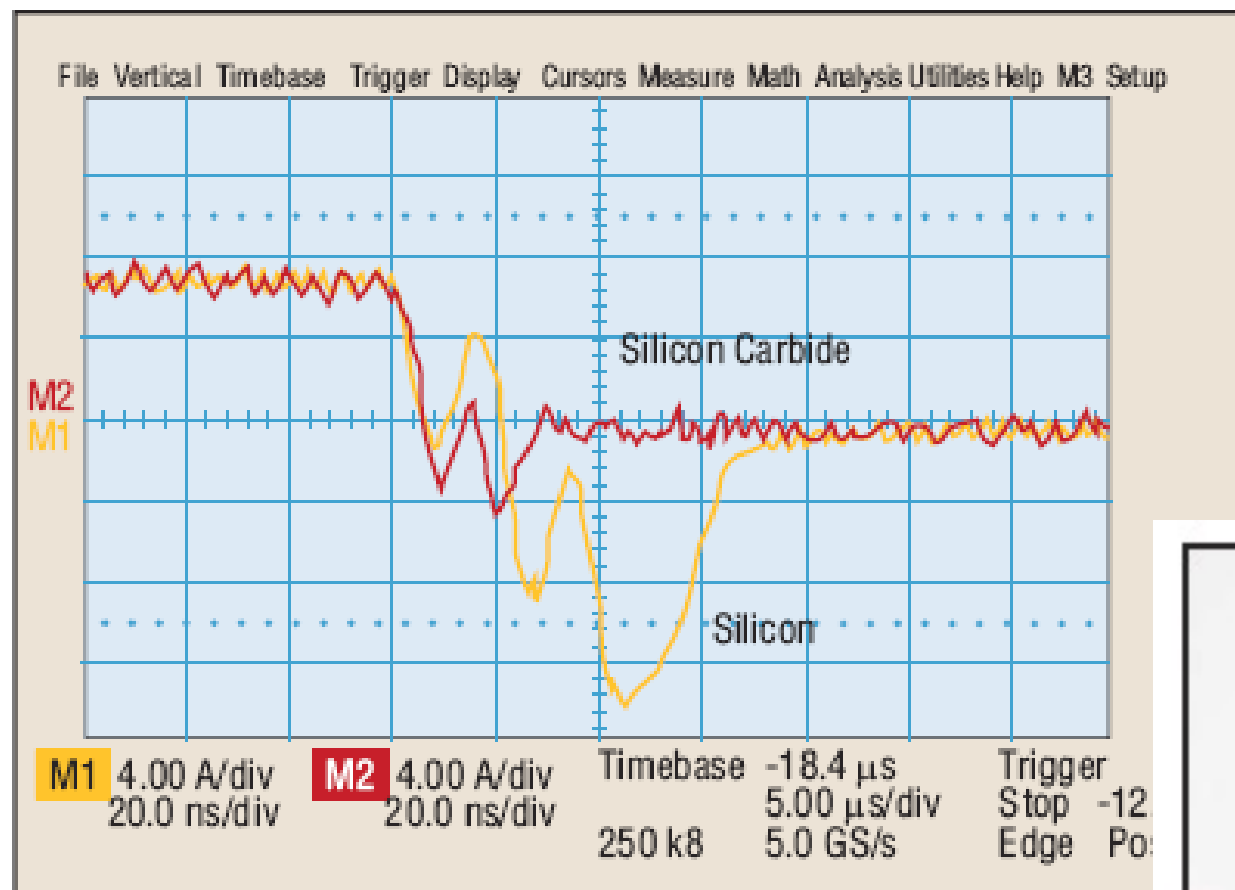


Fig. 4. Low-line diode recovery currents in PFC front-end converter

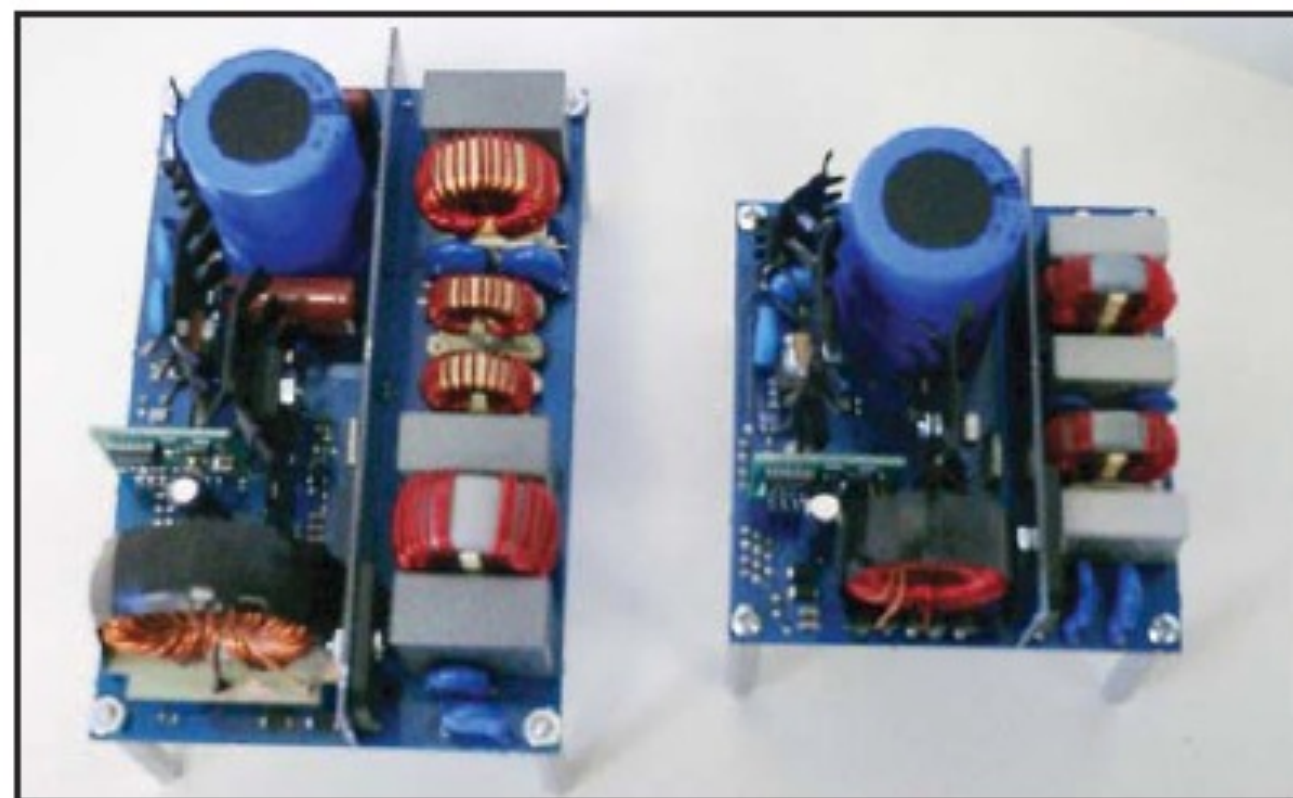


Fig. 8. A size comparison of an 80-kHz PFC front-end built with Si rectifiers (left) and a 200-kHz PFC front-end with SiC rectifiers.

Perdas nos Diodos

Classificação das perdas:

1. Condução;

$$P = V_{(TO)} \cdot I_{Dmed} + r_T \cdot I_{Def}^2$$

2. Comutação:

- Entrada em condução;

$$P_1 = 0,5(V_{FP} - V_F) I_o \cdot t_{rf} \cdot f$$

- Bloqueio.

$$P_2 = Q_{rr} \cdot E \cdot f$$

Características de Diodos Comerciais

Principais características:

- Tensão de pico reversa;
- Queda de tensão direta;
- Corrente de pico;
- Corrente média;
- Corrente eficaz;
- Tempo de recuperação reversa.

MURD320

THERMAL CHARACTERISTICS

Rating	Symbol	Value	Unit
Thermal Resistance – Junction-to-Case	$R_{\theta JC}$	6	$^{\circ}\text{C/W}$
Thermal Resistance – Junction-to-Ambient (Note 1)	$R_{\theta JA}$	80	$^{\circ}\text{C/W}$

ELECTRICAL CHARACTERISTICS

Maximum Instantaneous Forward Voltage Drop (Note 2) ($I_F = 3$ Amps, $T_J = 25^{\circ}\text{C}$) ($I_F = 3$ Amps, $T_J = 125^{\circ}\text{C}$)	V_F	0.95 0.75	Volts
Maximum Instantaneous Reverse Current (Note 2) ($T_J = 25^{\circ}\text{C}$, Rated dc Voltage) ($T_J = 125^{\circ}\text{C}$, Rated dc Voltage)	I_R	5 500	μA
Maximum Reverse Recovery Time ($I_F = 1$ Amp, $di/dt = 50$ Amps/ μs , $V_R = 30$ V, $T_J = 25^{\circ}\text{C}$) ($I_F = 0.5$ Amp, $I_R = 1$ Amp, $I_{REC} = 0.25$ A, $V_R = 30$ V, $T_J = 25^{\circ}\text{C}$)	t_{rr}	35 25	ns

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Peak Repetitive Reverse Voltage Working Peak Reverse Voltage DC Blocking Voltage	V_{RRM} V_{RWM} V_R	200	V
Average Rectified Forward Current (Rated V_R , $T_C = 158^{\circ}\text{C}$)	$I_{F(AV)}$	3.0	A
Peak Repetitive Forward Current (Rated V_R , Square Wave, 20 kHz, $T_C = 158^{\circ}\text{C}$)	I_{FRM}	6.0	A
Non-Repetitive Peak Surge Current (Surge Applied at Rated Load Conditions Halfwave, 60 Hz)	I_{FSM}	75	A
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-65 to +175	$^{\circ}\text{C}$

Características de Diodos Comerciais

Tipos de diodos:

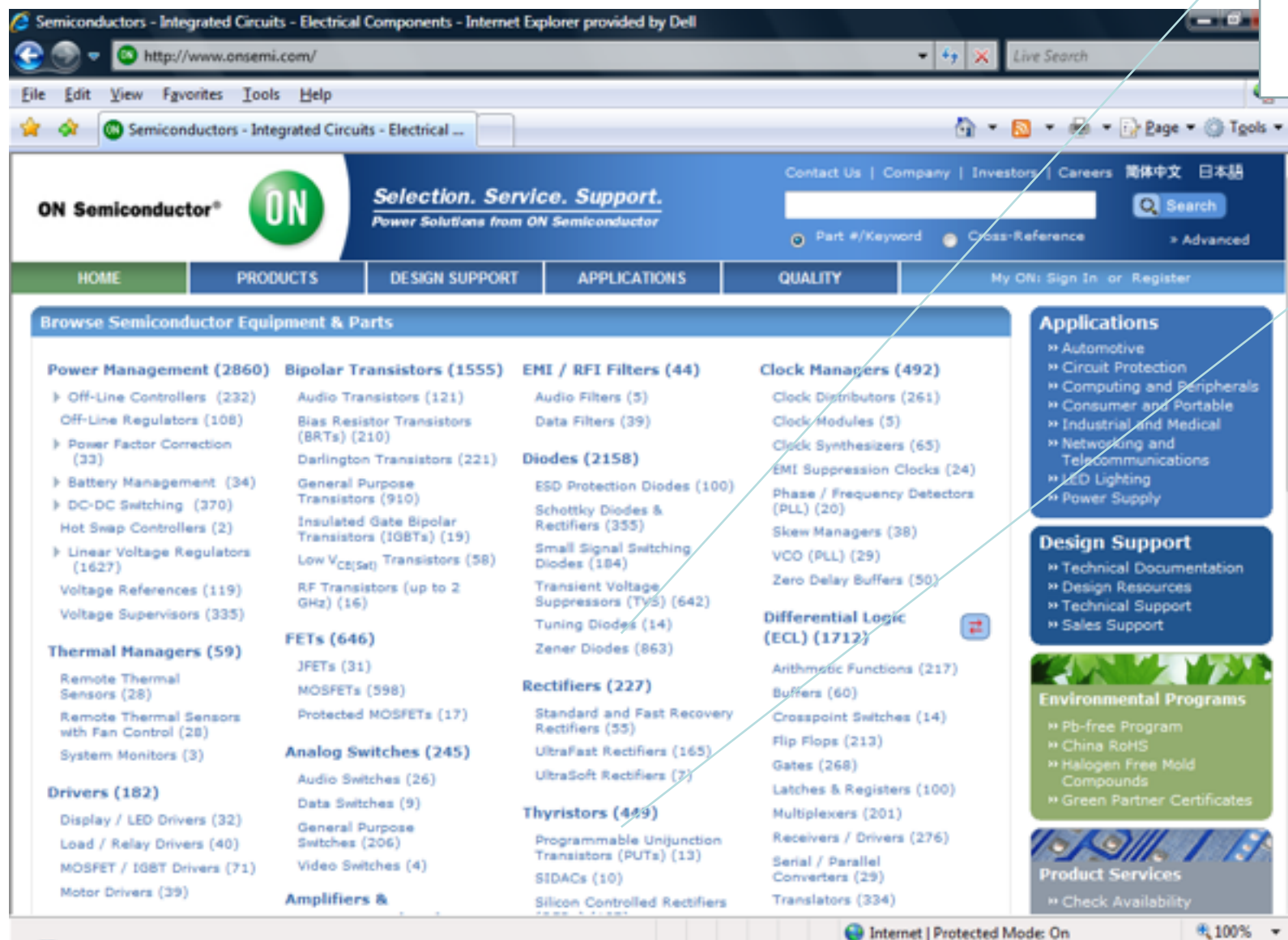
1. Standard and fast recovery;
2. Ultrafast rectifiers;
3. Ultrasoft rectifiers;
4. Silicon carbide (zero recovery).

Rectifiers (227)

Standard and Fast Recovery Rectifiers (55)

UltraFast Rectifiers (165)

UltraSoft Rectifiers (7)





C2D20120D–Silicon Carbide Schottky Diode

ZERO RECOVERY® RECTIFIER

$$V_{RRM} = 1200 \text{ V}$$

$$I_F = 20 \text{ A}$$

$$Q_c = 122 \text{ nC}$$

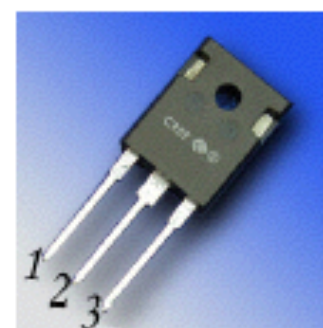
Features

- 1200-Volt Schottky Rectifier
- Zero Reverse Recovery
- Zero Forward Recovery
- High-Frequency Operation
- Temperature-Independent Switching Behavior
- Extremely Fast Switching
- Positive Temperature Coefficient on V_F

Benefits

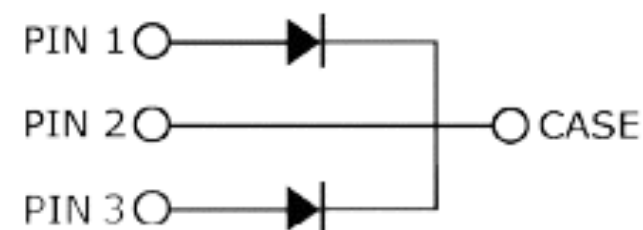
- Replace Bipolar with Unipolar Rectifiers
- Essentially No Switching Losses
- Higher Efficiency
- Reduction of Heat Sink Requirements
- Parallel Devices Without Thermal Runaway

Package



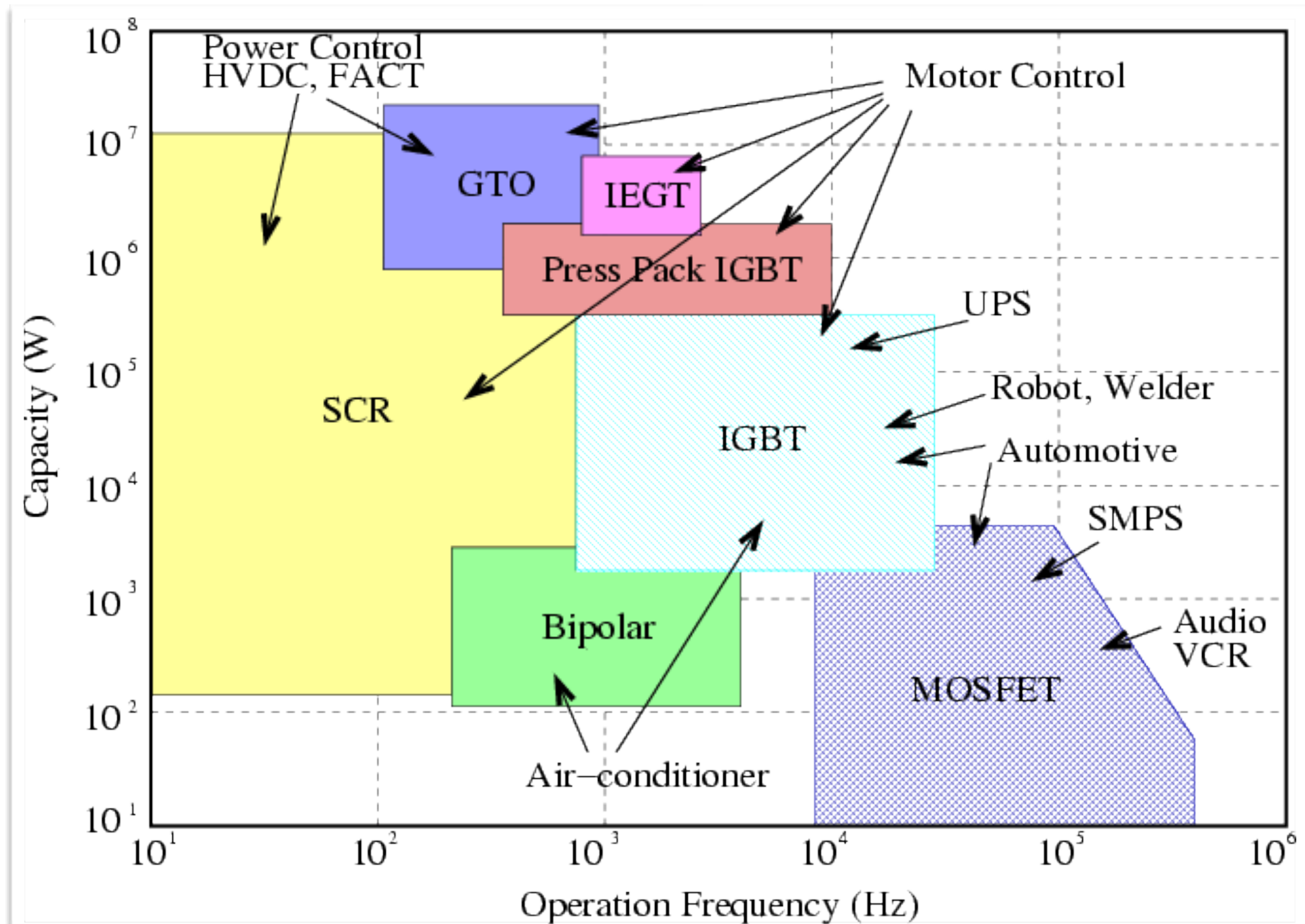
TO-247-3

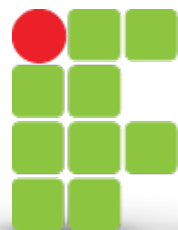
www.cree.com



Semicondutores de Potência

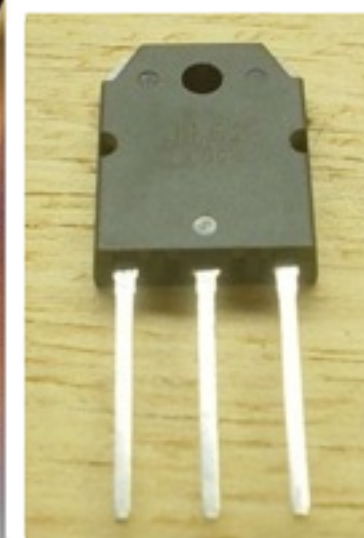
Semicondutores aplicados à eletrônica de potência:





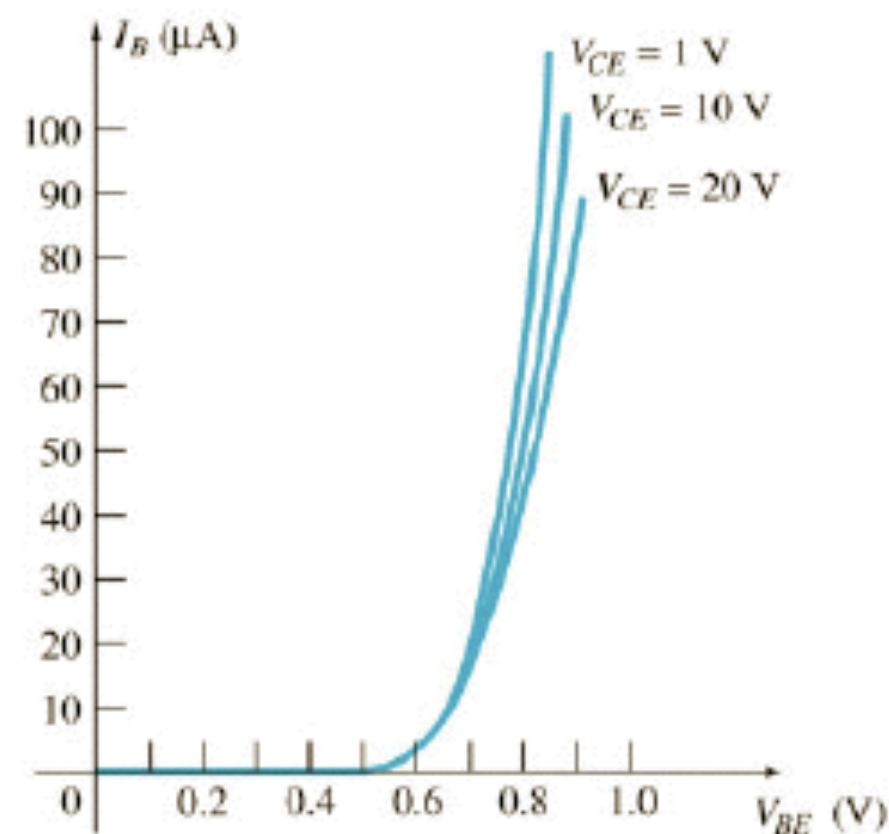
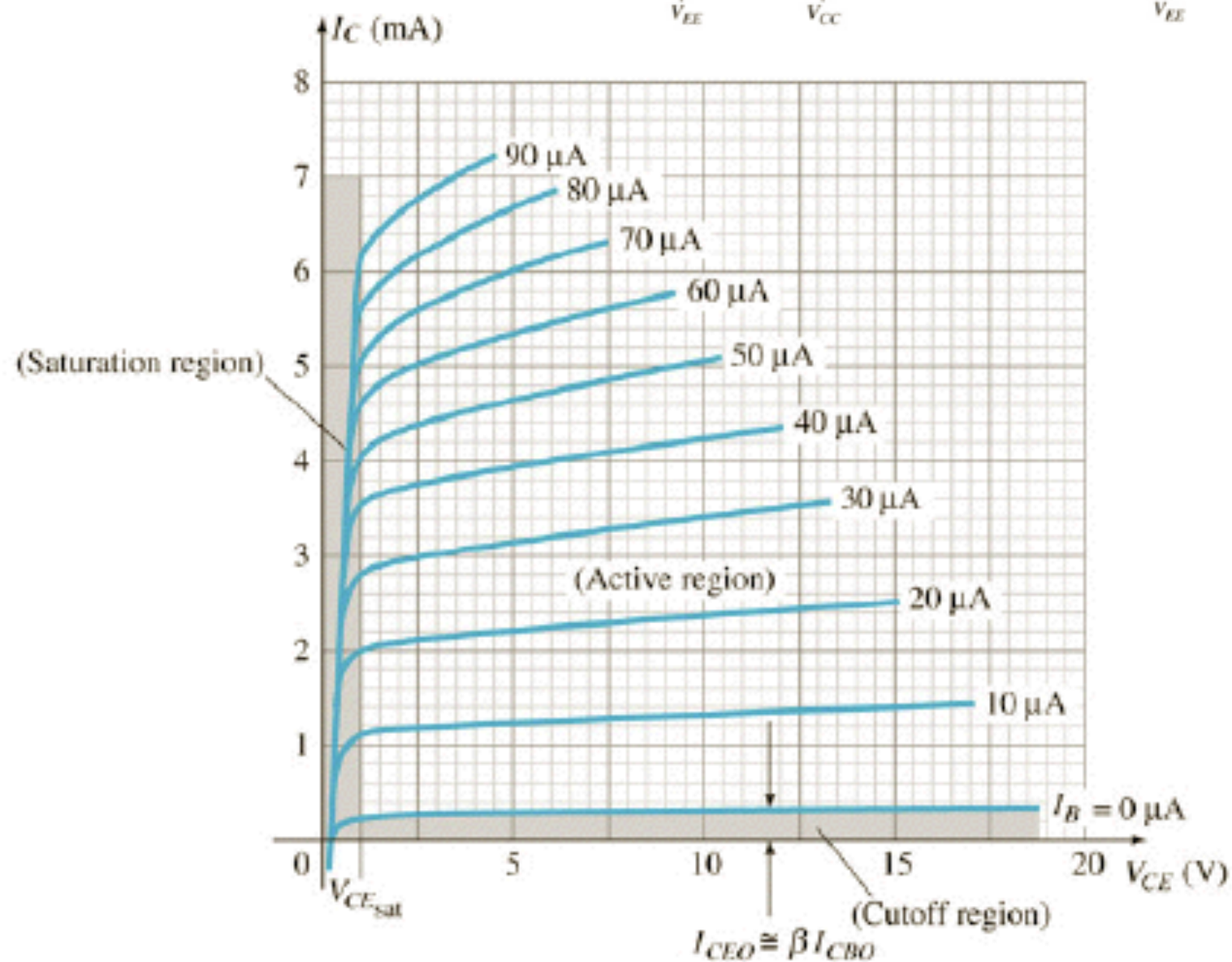
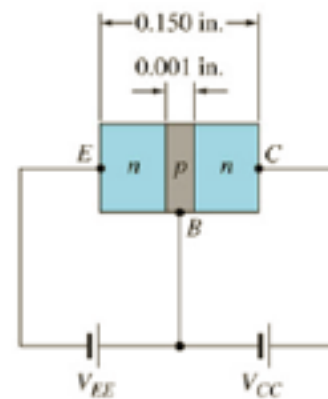
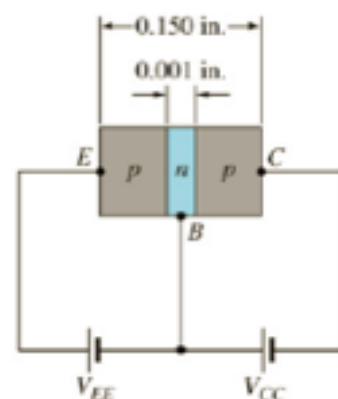
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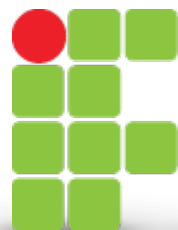
Semicondutores de Potência



Revisão - BJT

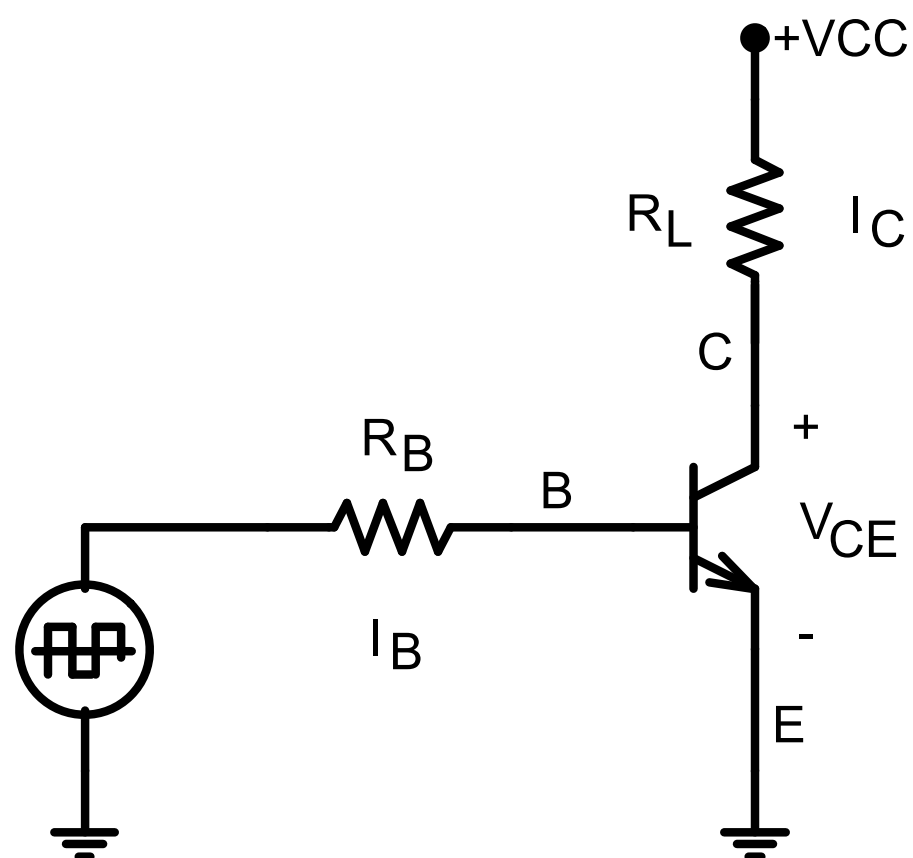
BJT - Transistor bipolar de junção





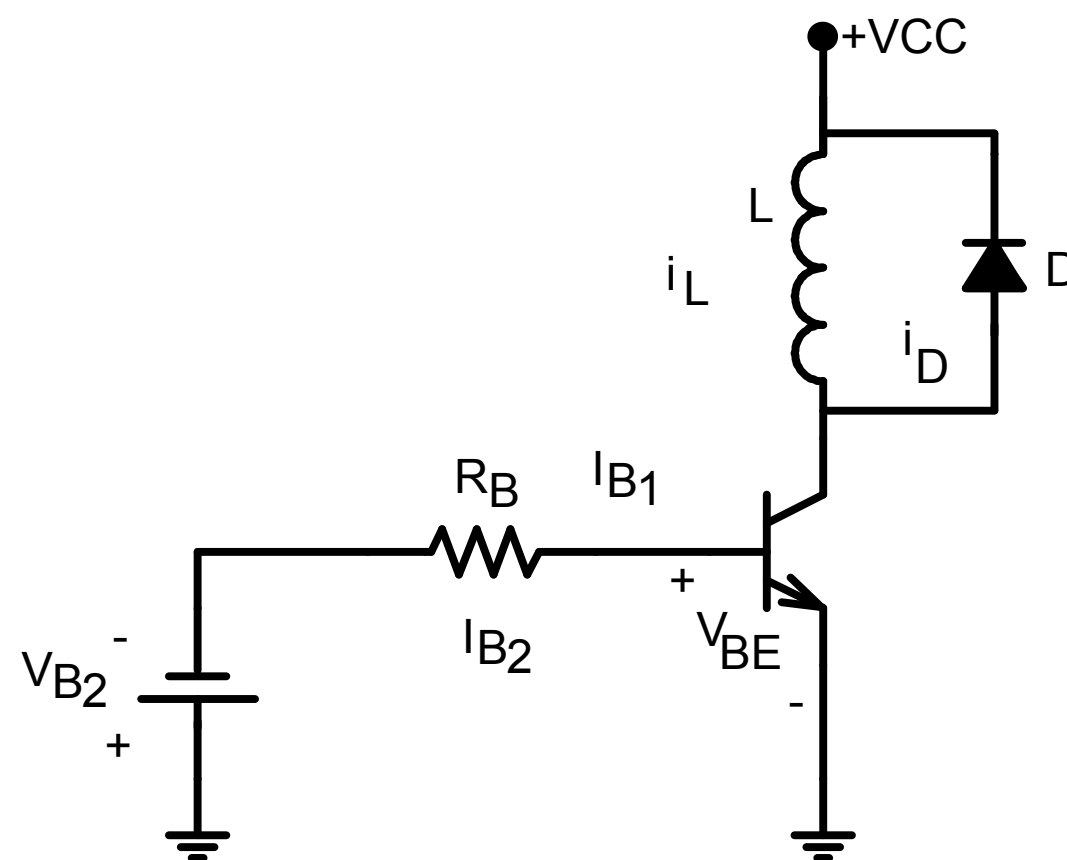
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BJT



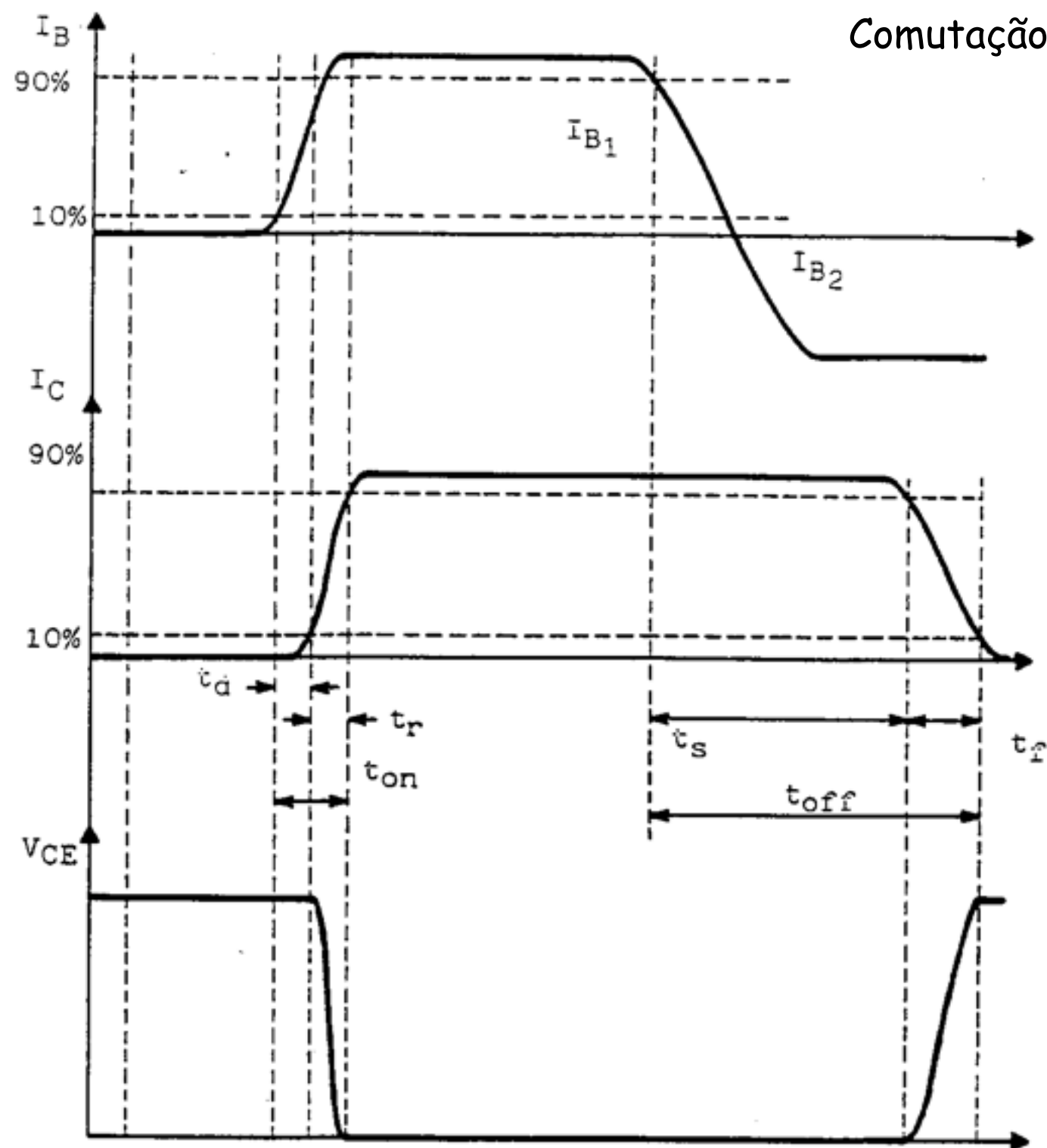
Comutação do BJT com carga resistiva

Comutação do BJT com carga indutiva



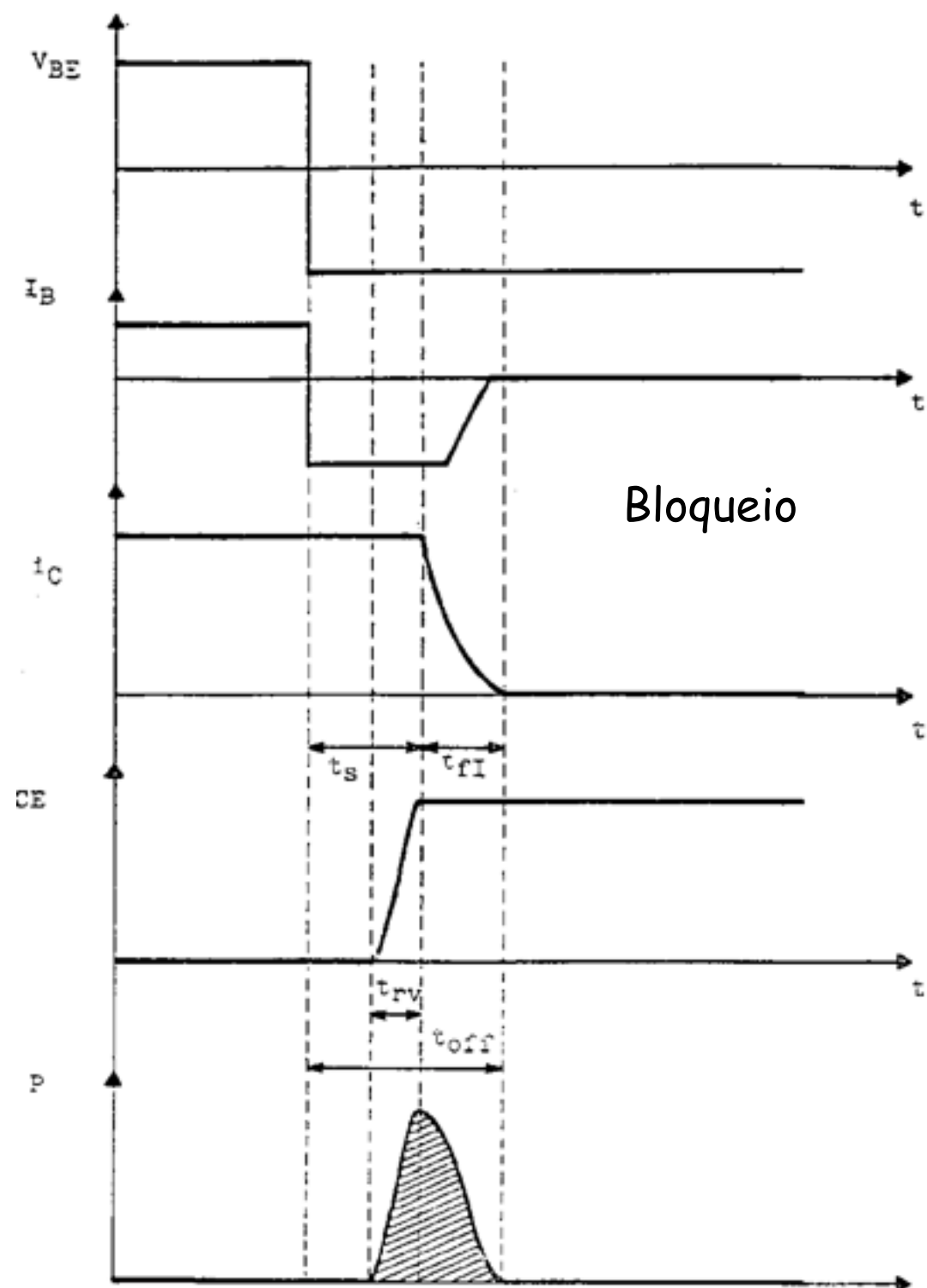
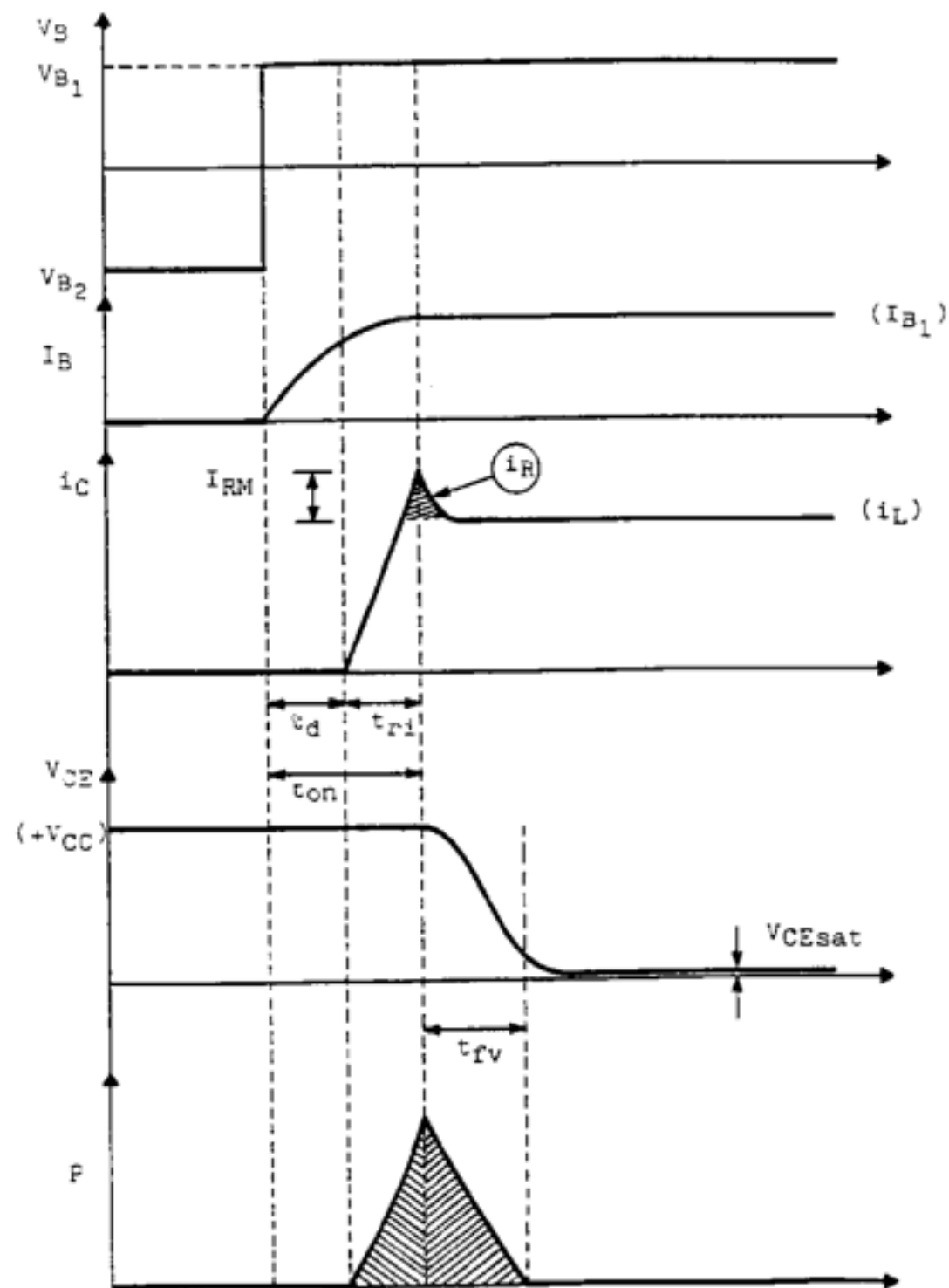
BJT

Comutação do BJT com carga resistiva



BJT

Entrada em condução



Bloqueio

Comutação do BJT com carga indutiva

The SiC BJT: Most Efficient 1200 V Power Conversion Switch Ever Made

A growing assortment of power switch technologies are on the market and in development today, including several that leverage the features of silicon carbide. Most promising among these choices are SiC bipolar junction transistors (BJTs). They offer very fast switching speed; the industry's lowest conduction losses; easy high temperature operation; very good robustness; and ease of manufacturing. Working in conjunction with a properly designed gate driver, SiC BJTs also offer safe operation with high ruggedness and reliability.

SiC BJT vs Si IGBT

	V	I	V _{CE}	E _{ON}	E _{OFF}
Si IGBT	1200	40	3	2500	1800
SiC BJT	1200	40	1.6	1000	600
Improvement (lowered by)			47%	60%	67%

SiC BJT Features

Lowest Losses on the Market

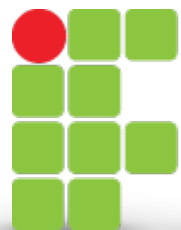
- Lowest conduction losses ($R_{ON} < 2.2 \text{ m}\Omega\text{cm}^2$ @ RT)
- Very low switching losses
- Lowest total losses; including driver losses
- High gain; SiC BJT DC current gain > 70

Fast Switching

- Approximately 20 ns for turn-on and turn-off
- Switching behavior is not temperature dependent
- No current tailing for SiC BJT

Robust and Reliable

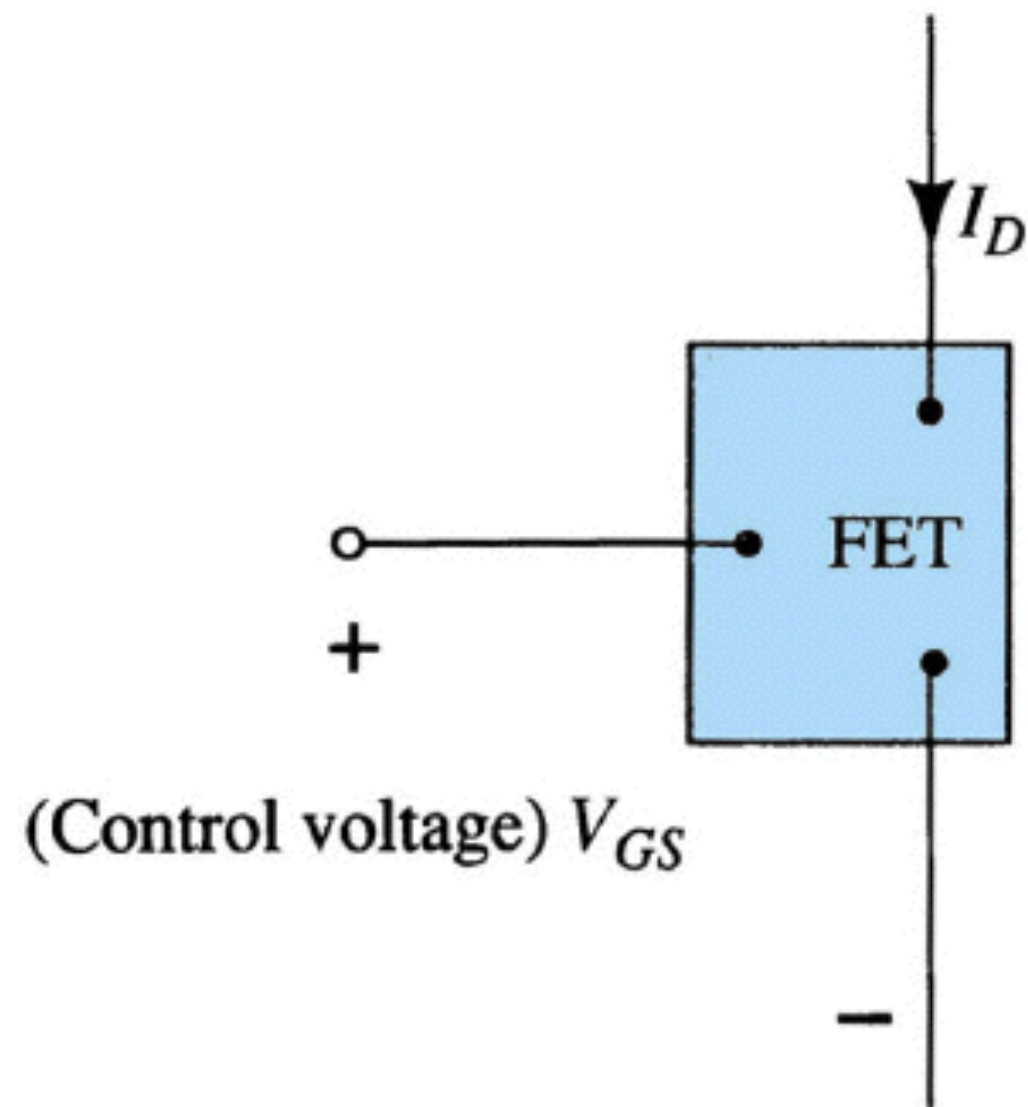
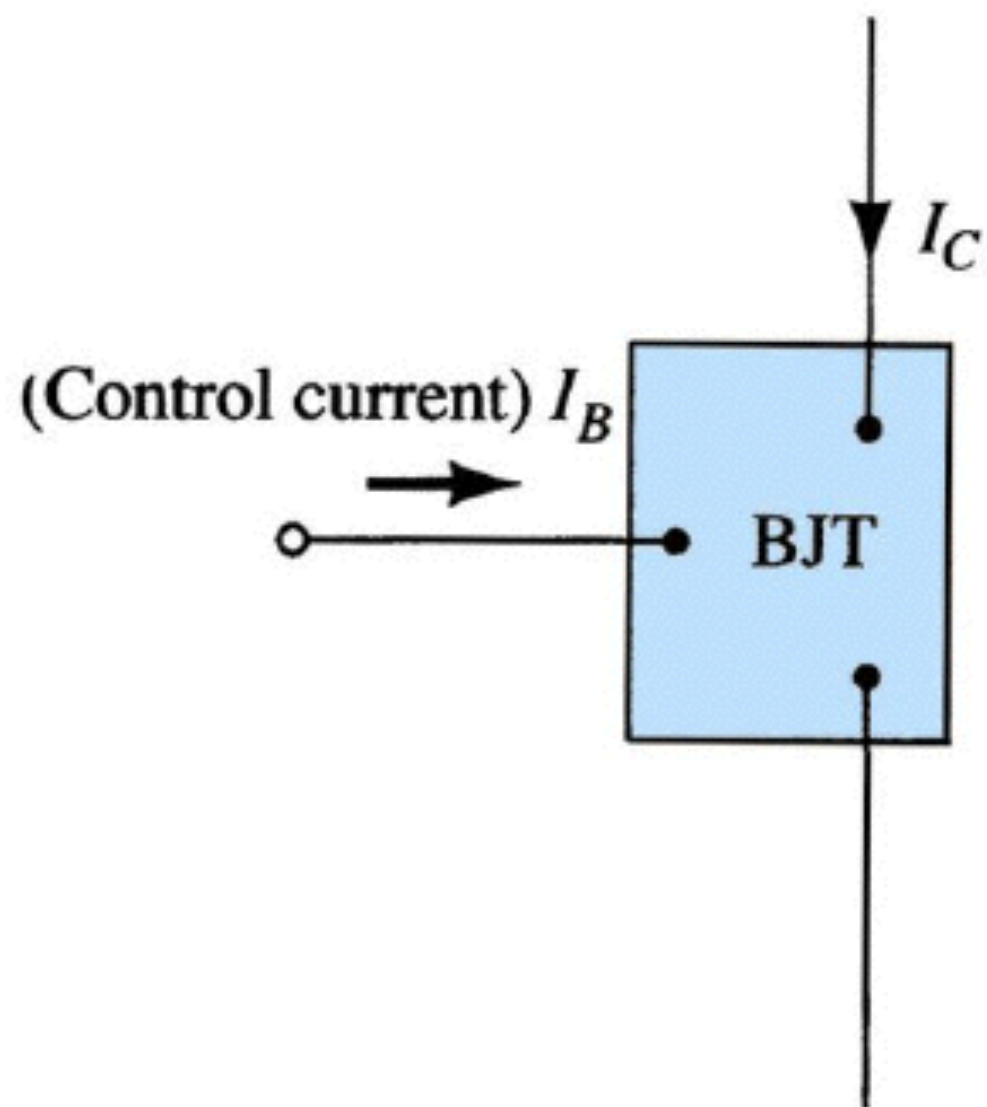
- Normally OFF device
- Highest rated operating temperature; $T_J = 175^\circ\text{C}$
- Positive temperature coefficient (R_{ON}); Easy paralleling
- No secondary breakdown for SiC BJT
- No SiO_2 gate oxide reliability issue
- Short circuit resistant
- Low leakage current

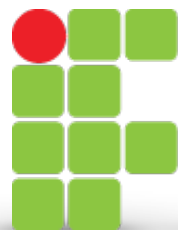


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BJT x FET

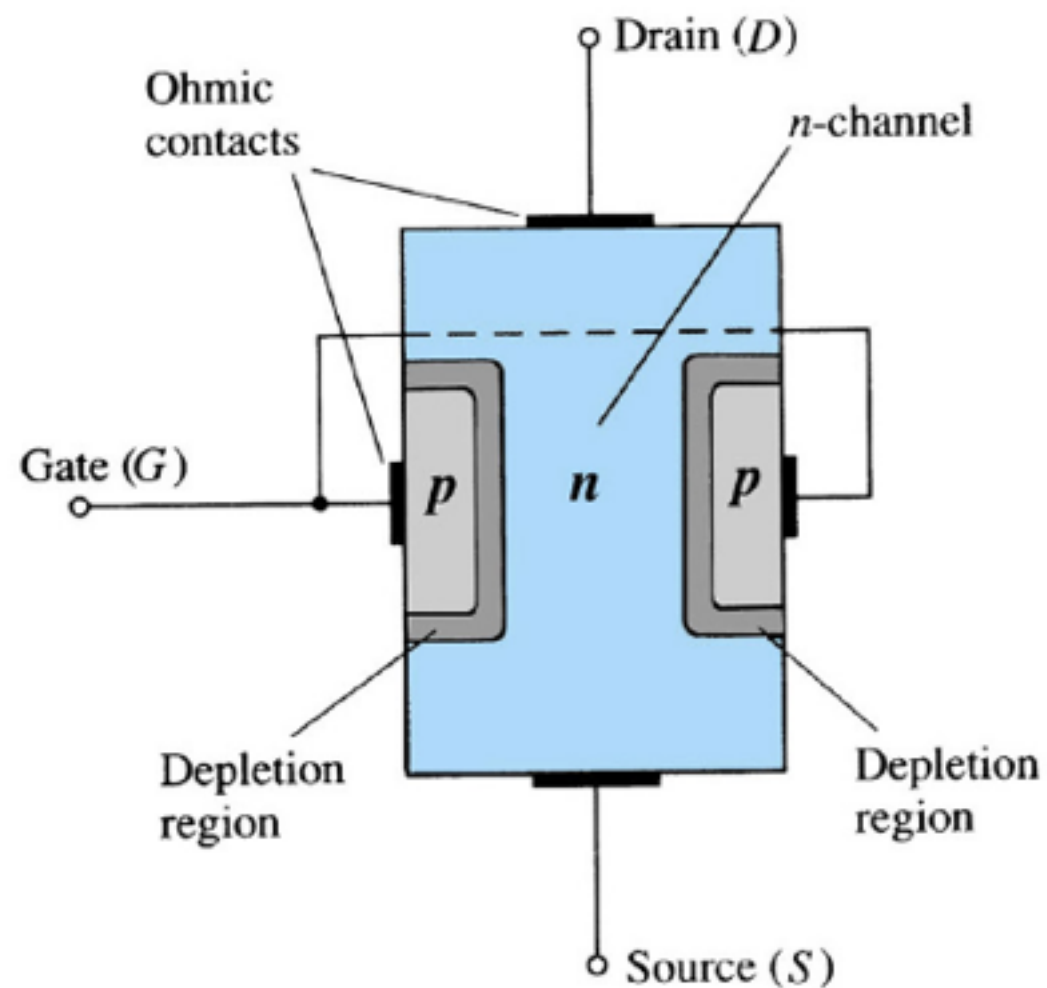
FET - Transistor de efeito de campo



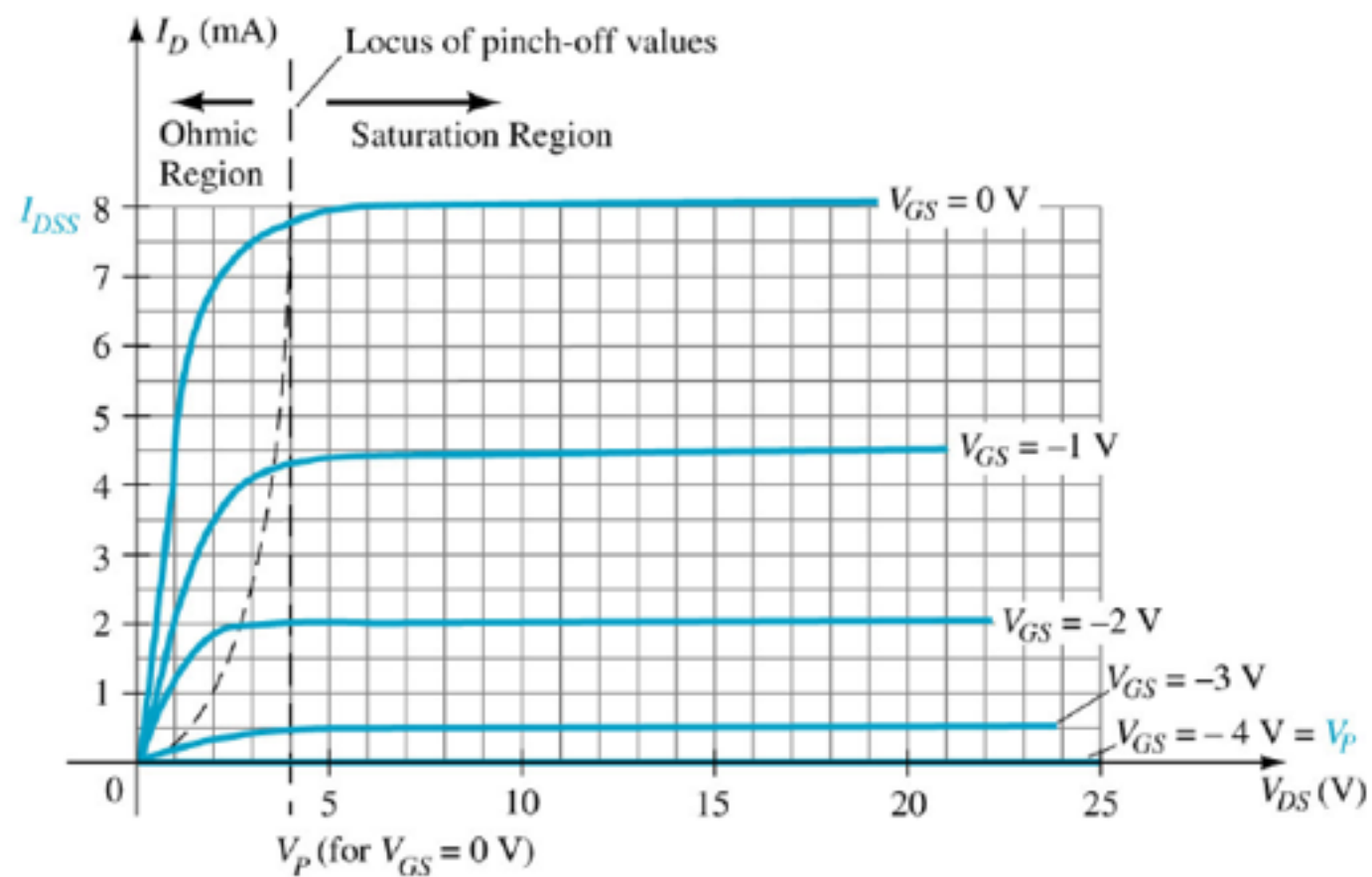
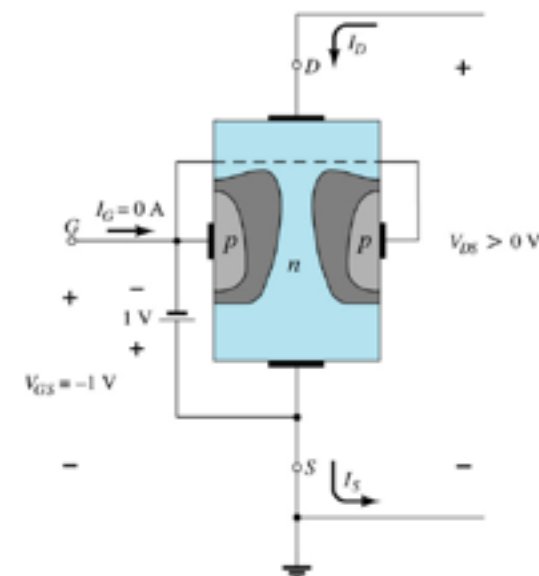
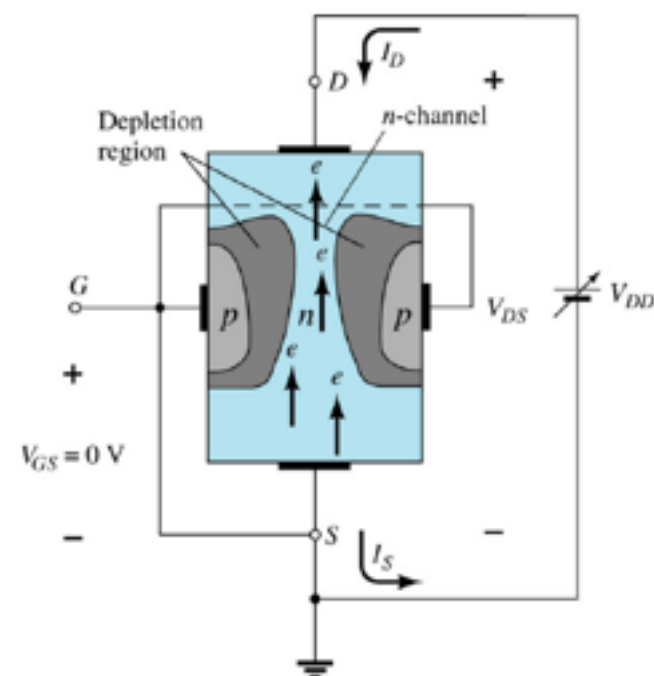


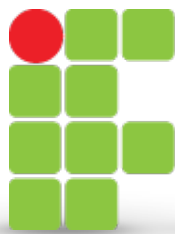
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FET



JFET: Operação básica





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FET

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http://jas.eng.buffalo.edu/

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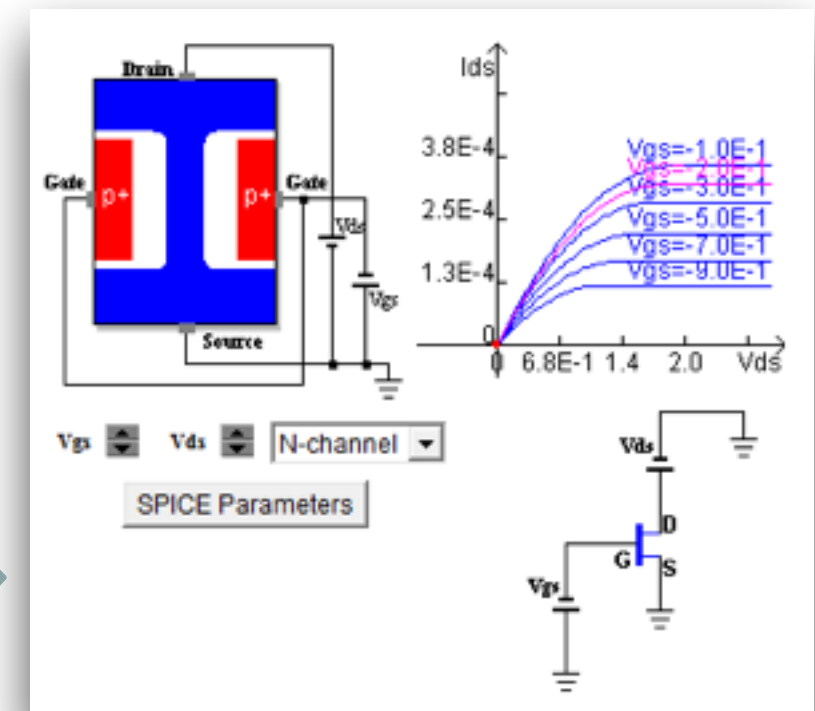
The Semiconductor Applet Service

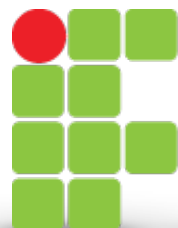
(Supported in part by the National Science Foundation)

List of Simulation Applets

- Crystal Structure**
 - Zincblende and Diamond structures (GaAs, Si, etc.): [unitcell with a list of material property](#). It gives you the 3D views of the unitcell and the covalent bonds.
 - [Hexagonal Closed Packed structures](#) (ZnS, GaN, SiC, etc.). An interactive 3D view of the crystal unitcell.
 - [Crystal Structure and the 14 Bravais Lattices](#) (java1.3): you can add various Basis atoms, rotate the crystal with one or multiple unitcells for a 3D view. It has many example crystals. You can also view the lattice planes and directions. [Crystal Structure in Java 3D !](#) (Java3D plugin maybe needed: use link in page)
- Energy Bands and Charge Carriers**
 - Visualization of [diffusion, drift and recombination](#) of excess minority carriers in a semiconductor.
 - [Indirect recombination via an energy state in the band gap](#). It also introduces the four basic processes in the Shockley-Read-Hall statistics.
 - Energy Band Diagram and E-k Diagram
 - [AlGaAs](#)
 - [SiGe](#)
- Charge Carriers and Fermi Level** [Semiconductor Statistics]
 - [Fermi Function and Localized Energy States](#) and the Temperature effect.

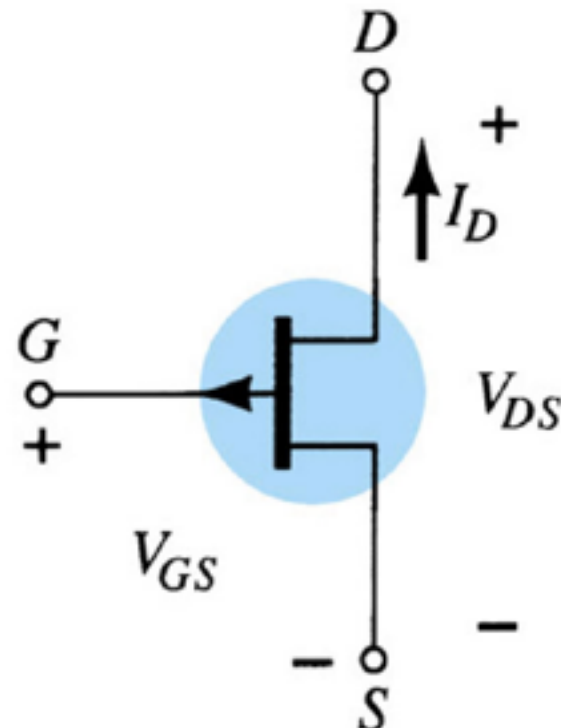
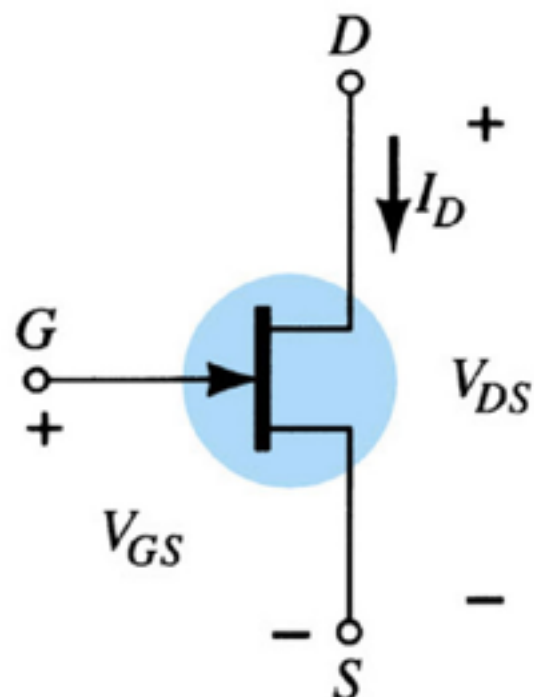
<http://jas.eng.buffalo.edu/>



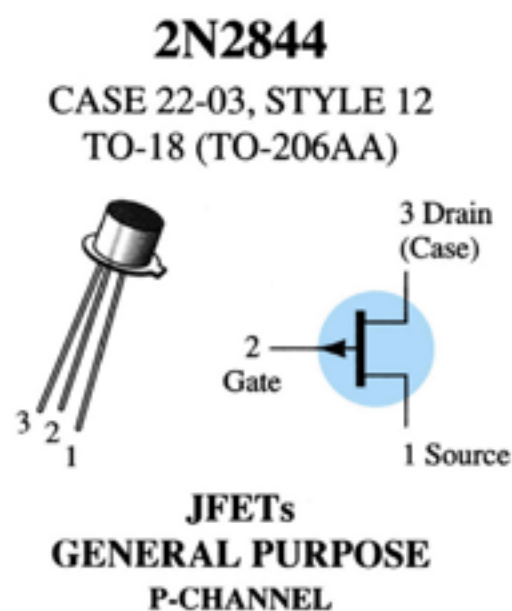
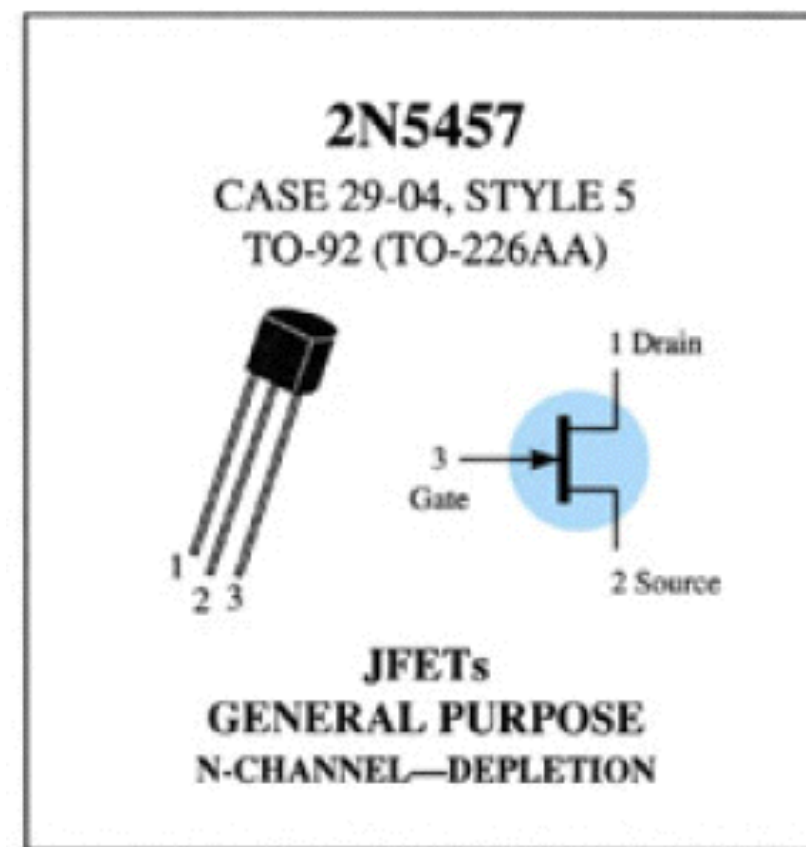


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FET

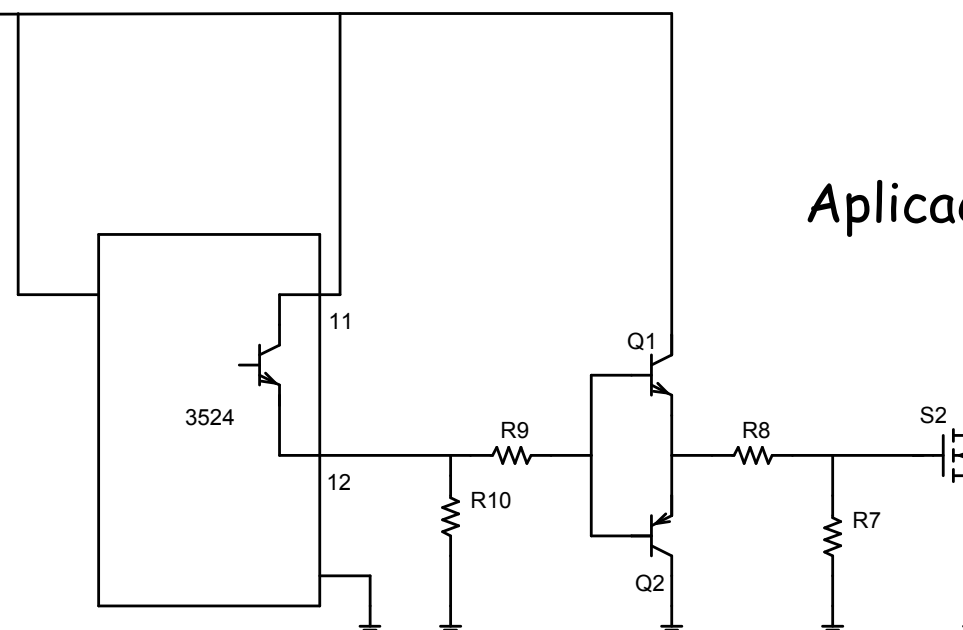


JFET canal n e canal p



Positivo da Fonte Auxiliar

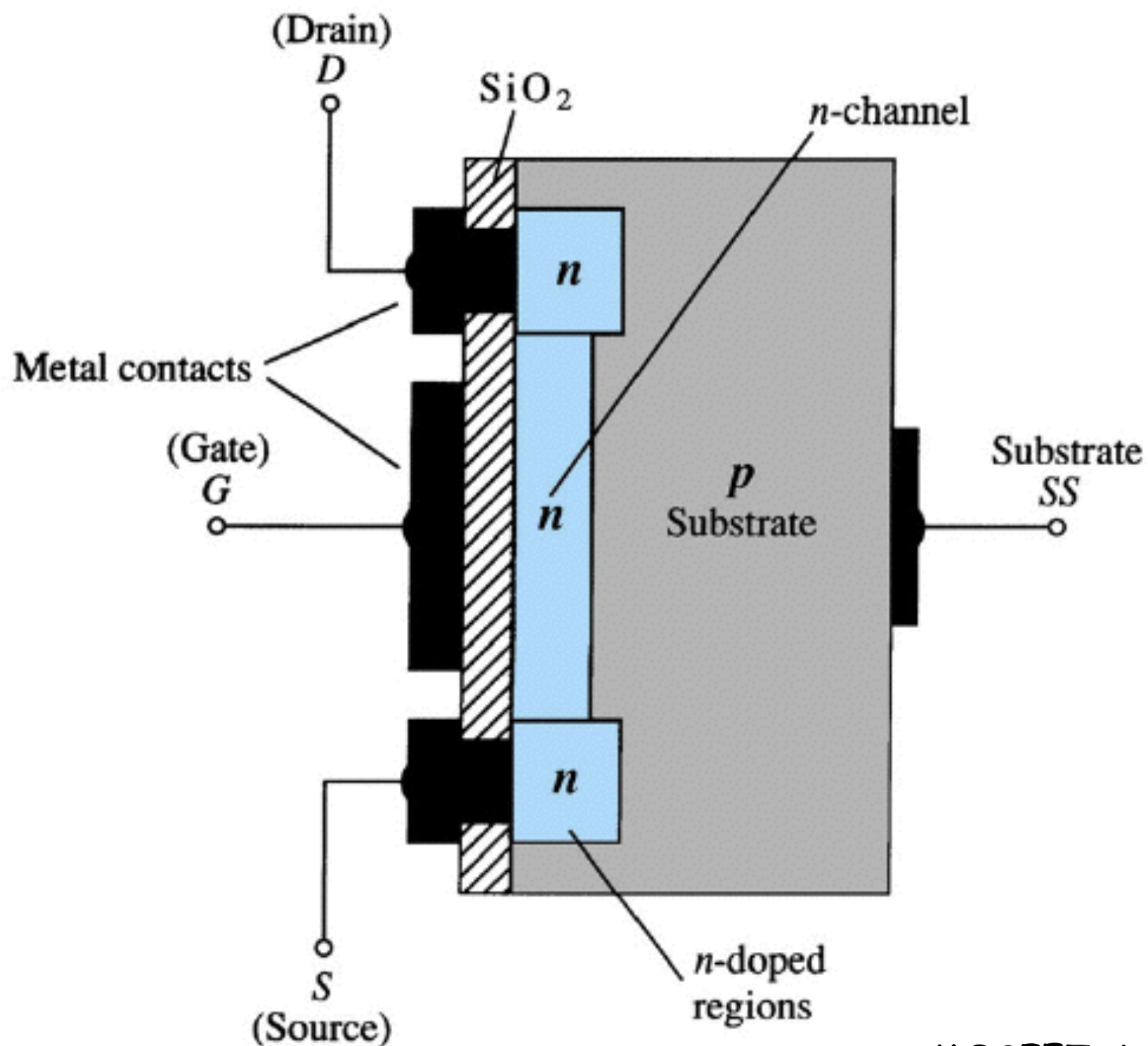
+ Vaux



Aplicação do JFET

MOSFET

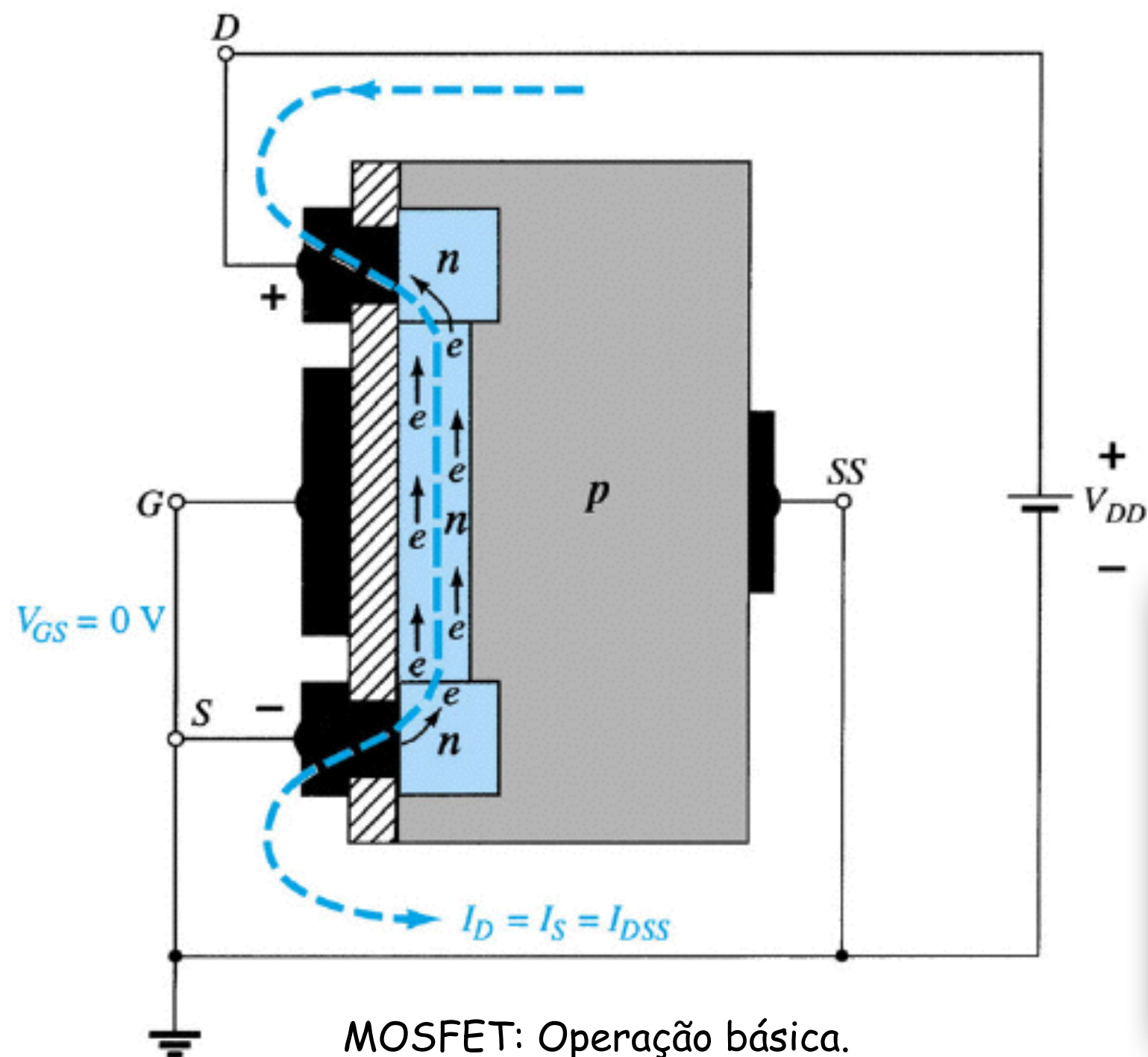
MOSFET - Metal Oxide Semiconductor Field Effect Transistor



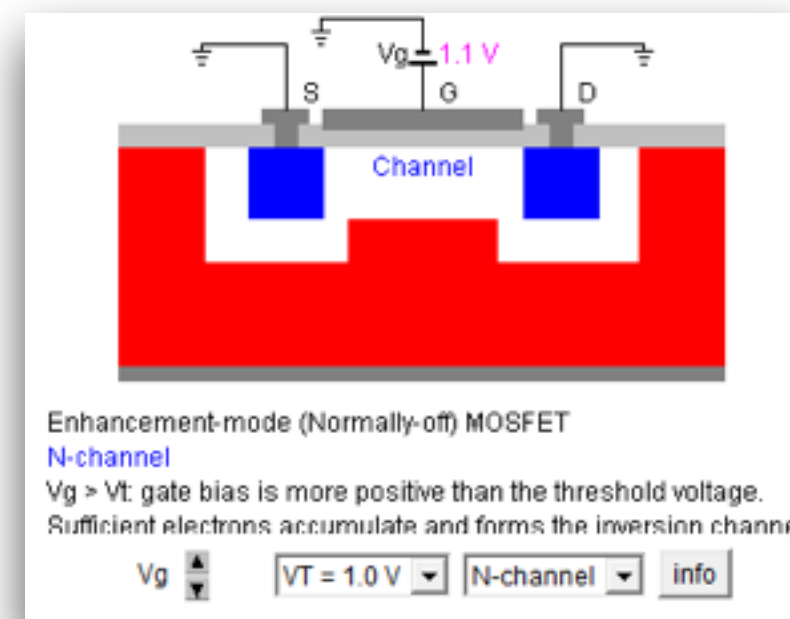
MOSFET tipo Depleção

MOSFET

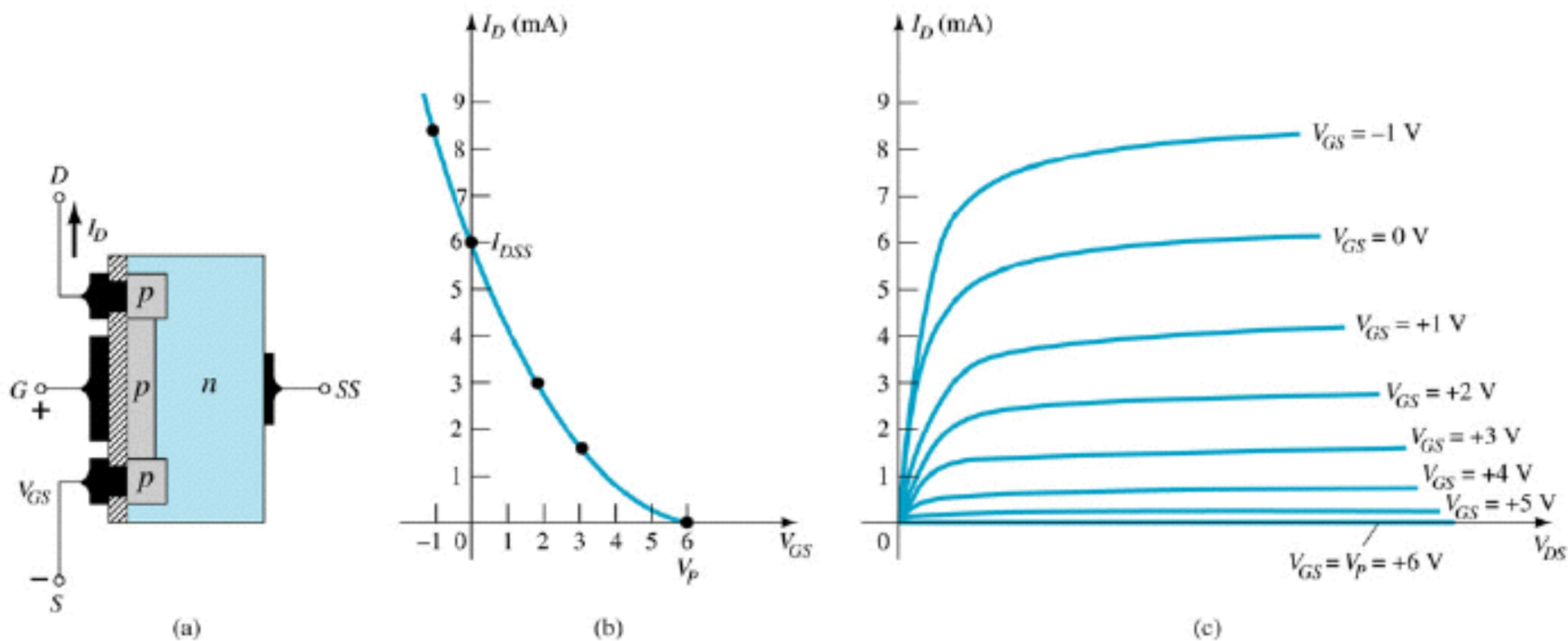
MOSFET tipo Depleção



MOSFET: Operação básica.



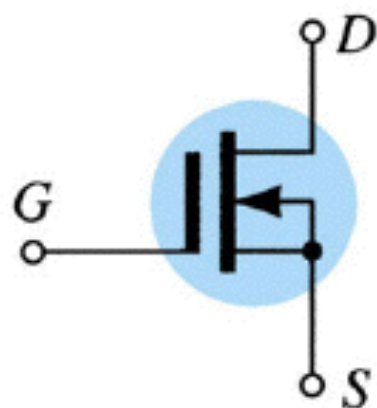
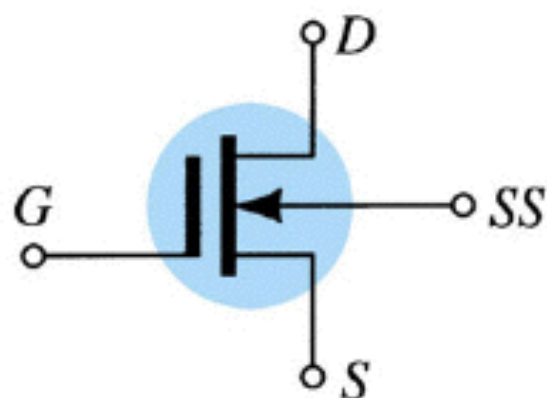
MOSFET tipo Depleção



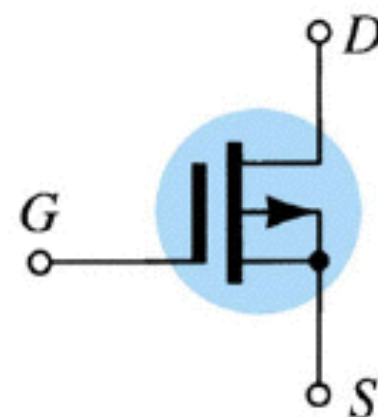
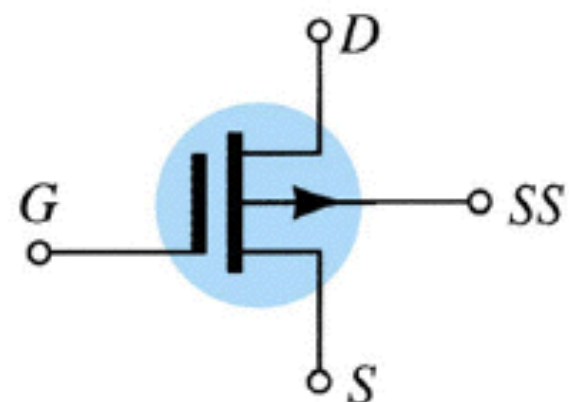
MOSFET: Operação básica.

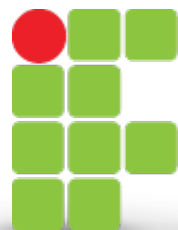
MOSFET tipo Depleção

n-channel



p-channel

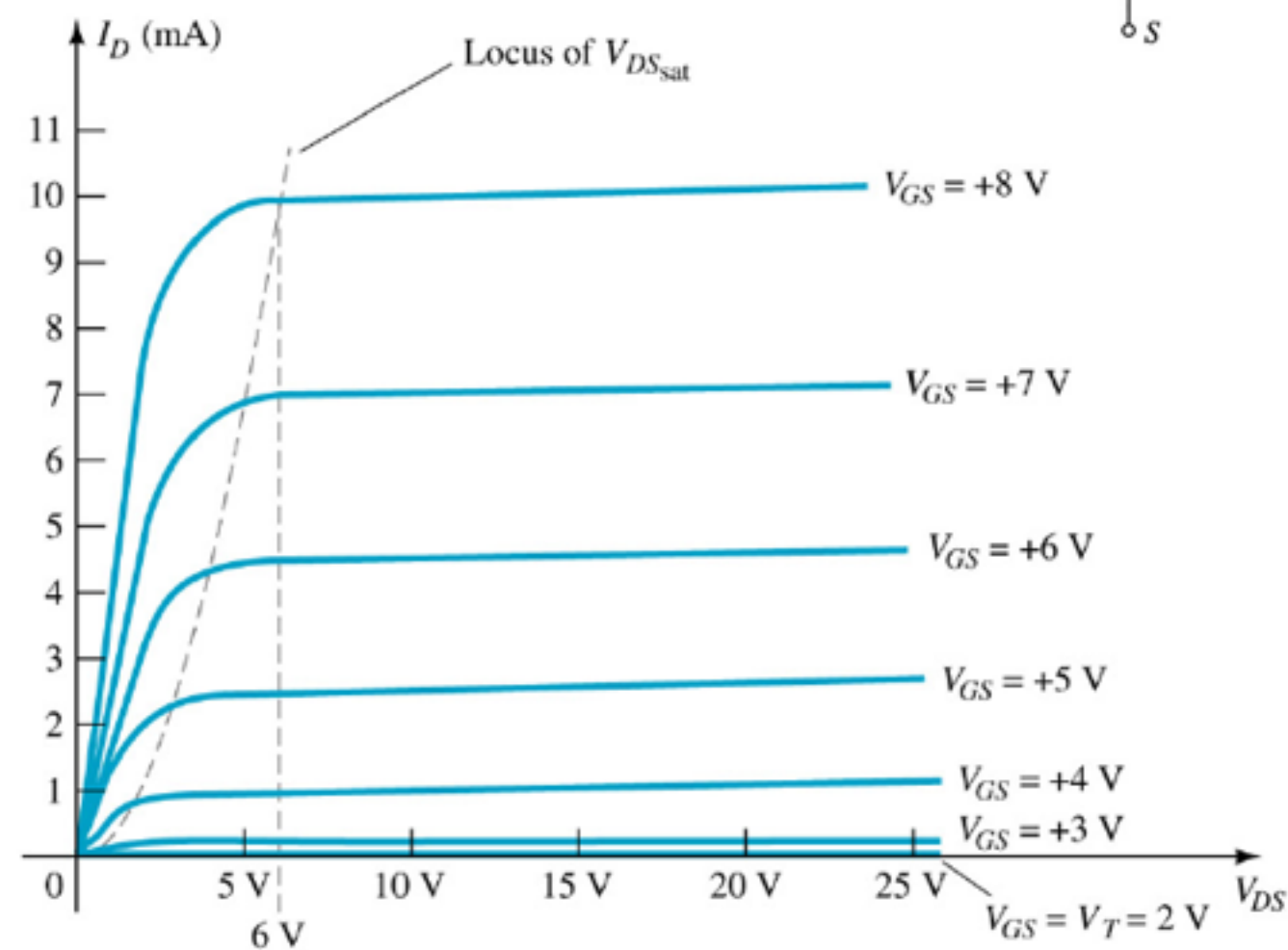
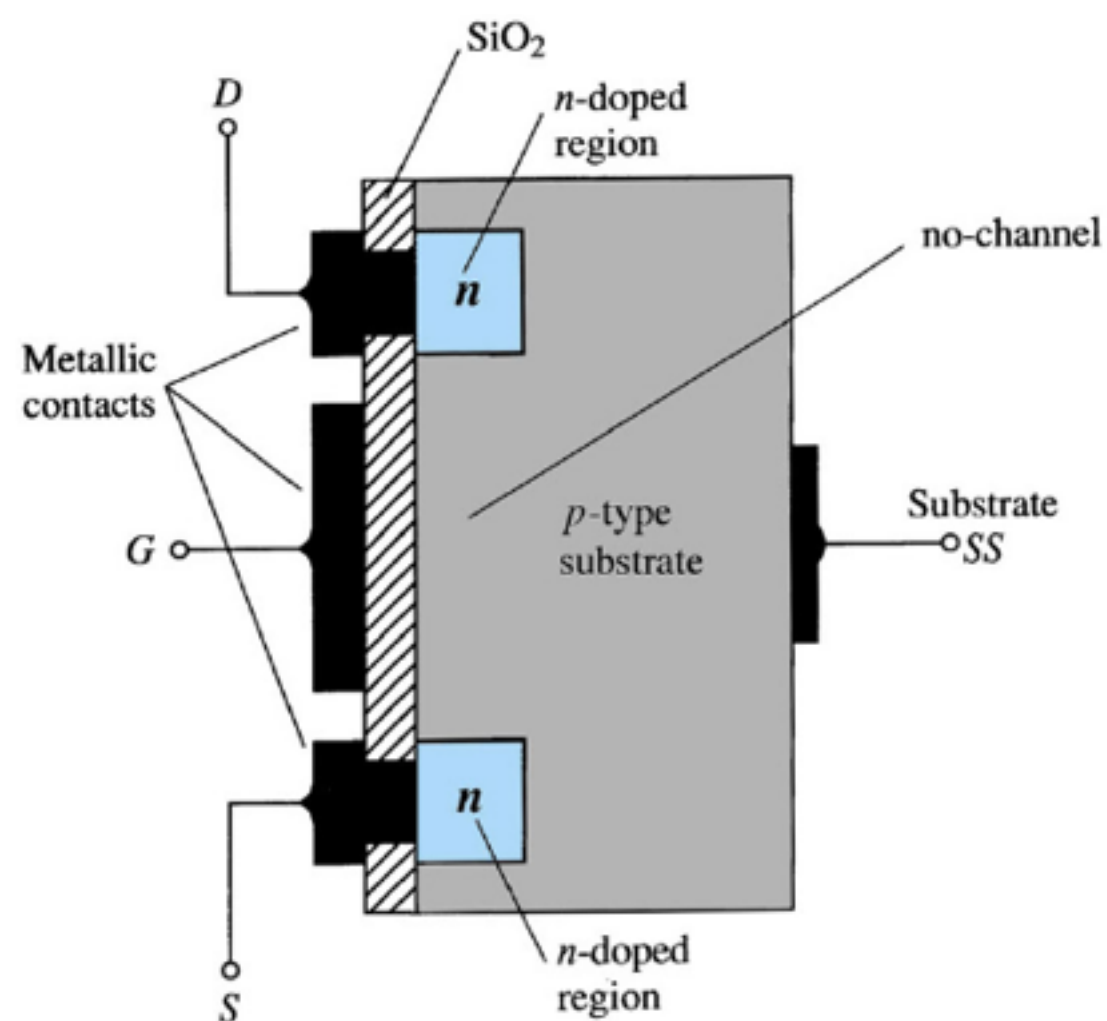




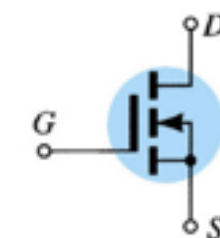
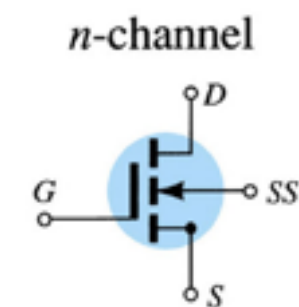
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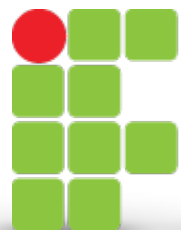
MOSFET

MOSFET tipo Intensificação



Canal n

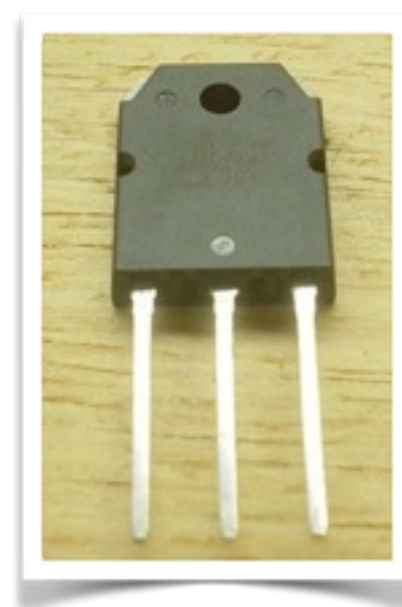
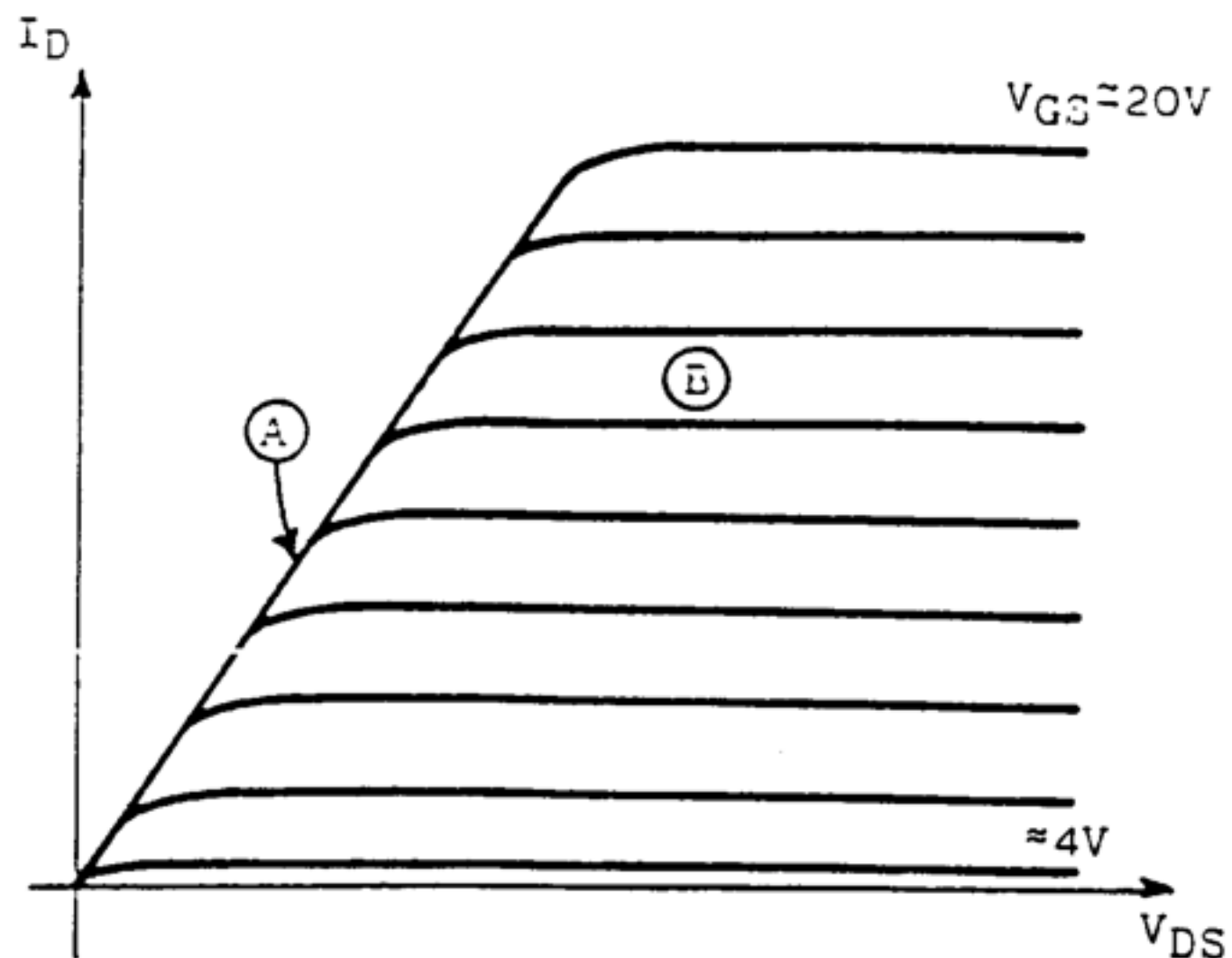
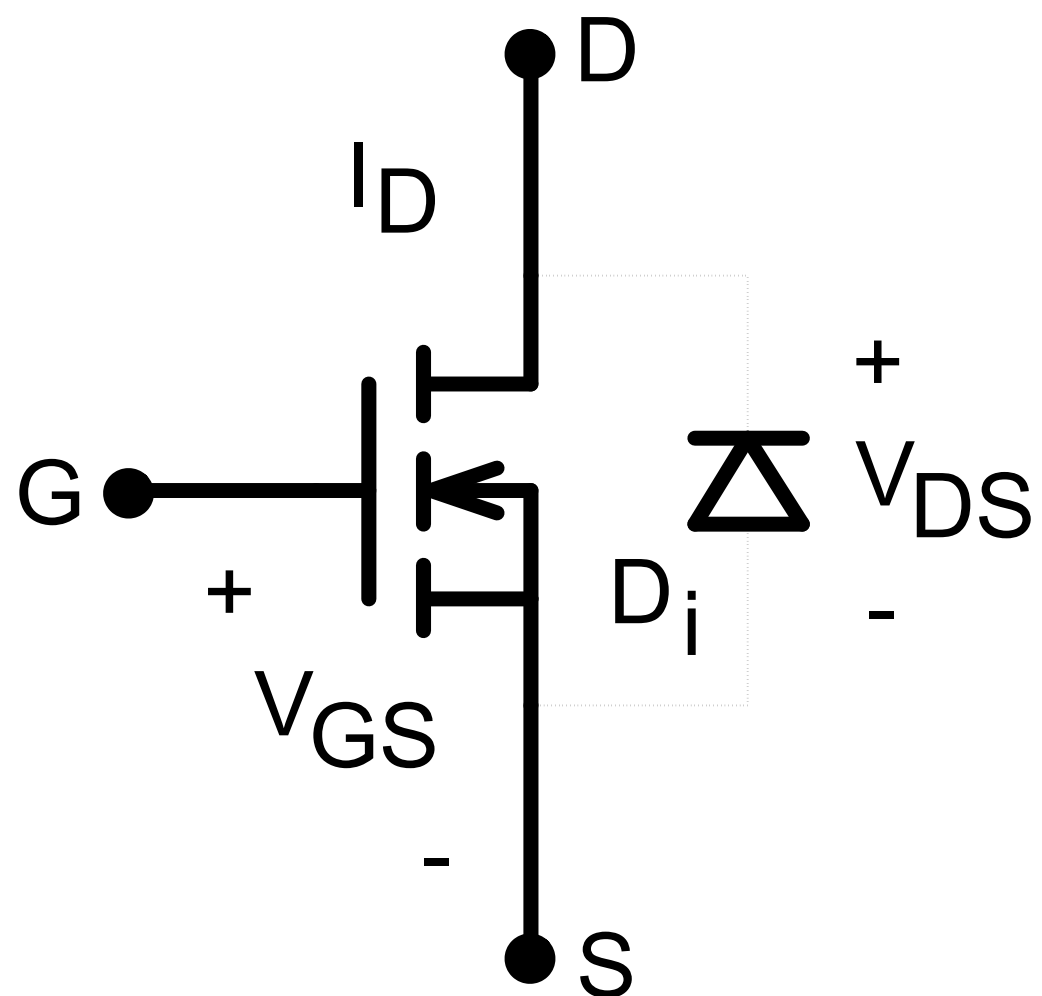


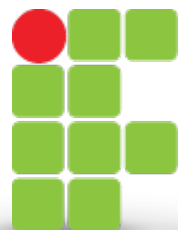


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MOSFET

MOSFET de Potência

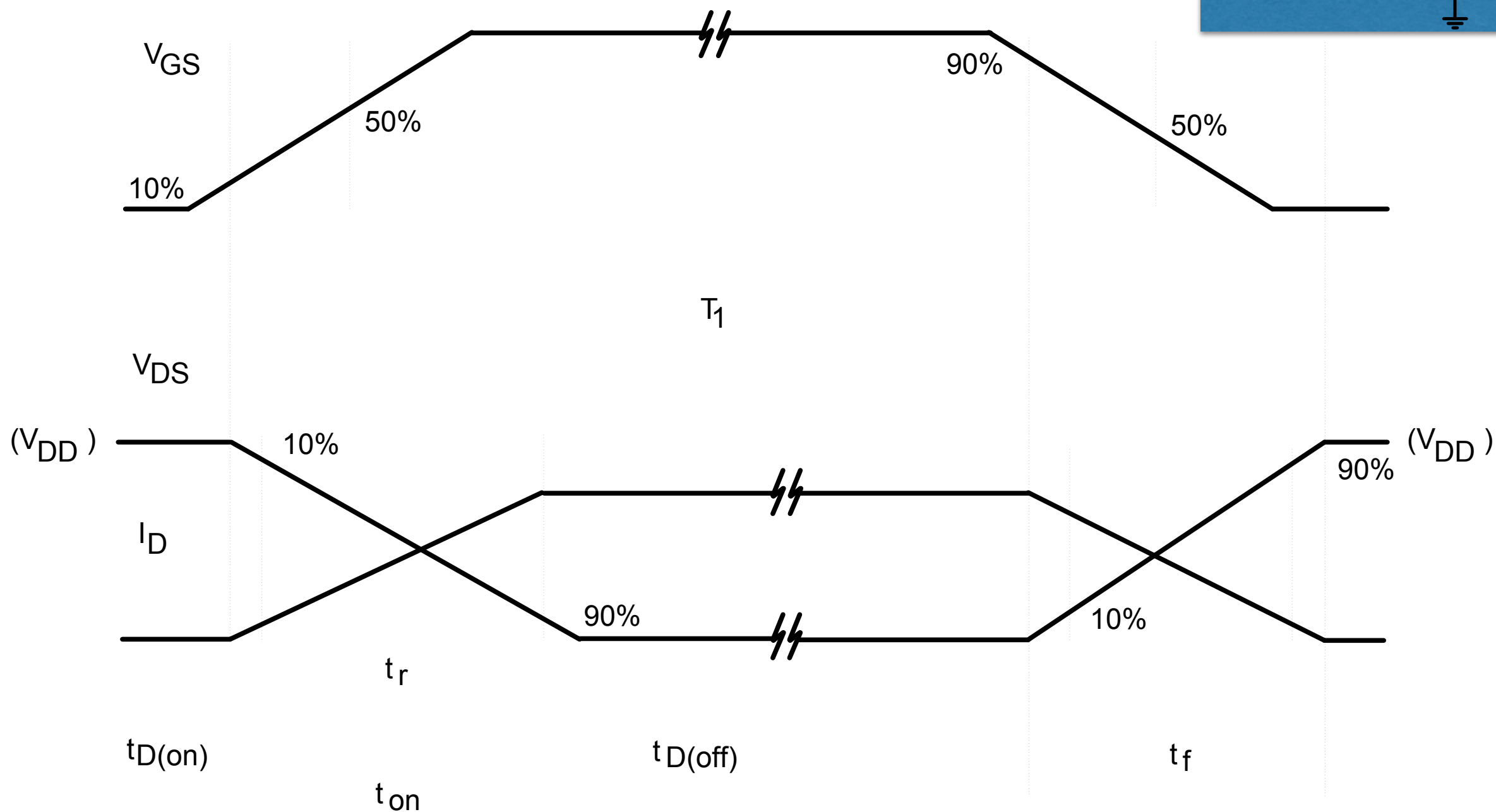
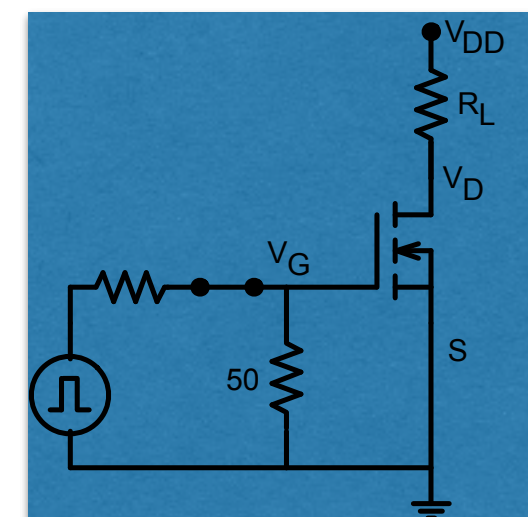




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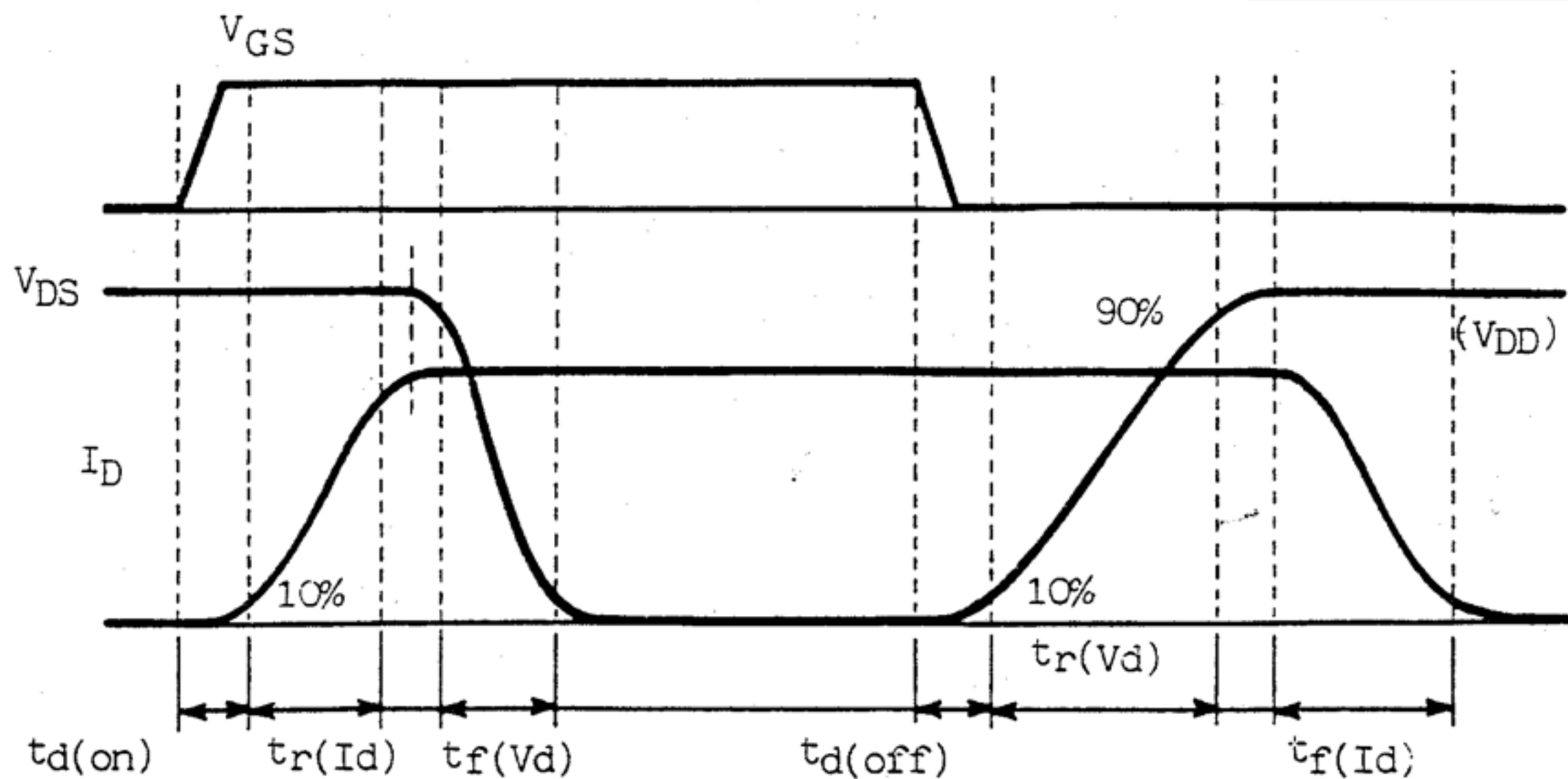
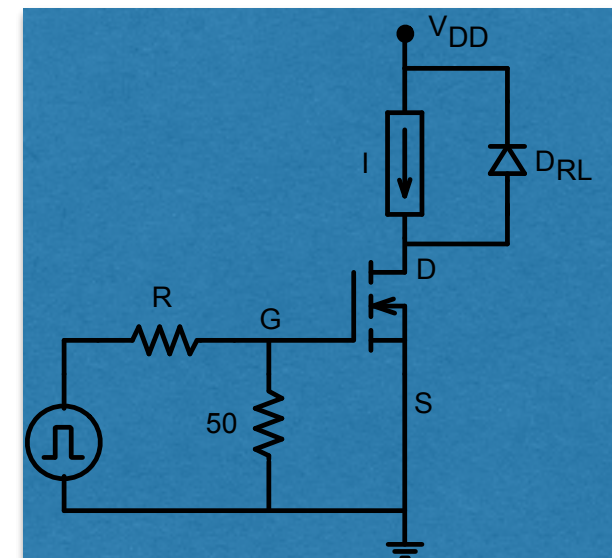
MOSFET

MOSFET de Potência



Comutação do MOSFET com carga resistiva

MOSFET de Potência



Comutação do MOSFET com carga indutiva

Classificação das perdas:

1. Condução;

$$P_{cond} = \frac{t_{on}}{T} \cdot r_{ds(on)} \cdot i_{d(on)}^2$$

2. Comutação:

- Entrada em condução e bloqueio;

- Onde:

$$t_f \cong t_{on}$$

$$t_r \cong t_{off}$$

Dados de catalogo:

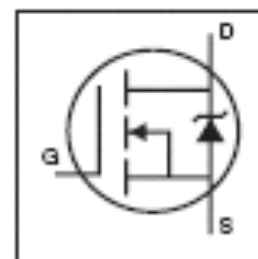
International
IR Rectifier

PD - 94459A

IRFP150V

HEXFET® Power MOSFET

- Advanced Process Technology
- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated



$$V_{DS} = 100V$$

$$R_{DS(on)} = 24m\Omega$$

$$I_D = 47A$$

Description

Advanced HEXFET® Power MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because of its isolated mounting hole.



Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	48	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	32	
I_{DM}	Pulsed Drain Current ①	230	
$P_D @ T_C = 25^\circ C$	Power Dissipation	140	W
	Linear Derating Factor	0.01	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
I_{AR}	Avalanche Current ②	28	A
E_{AR}	Repetitive Avalanche Energy ③	20	mJ
dv/dt	Peak Diode Recovery dv/dt ④	5.8	V/ns
T_J	Operating Junction and	-55 to +175	°C
T_{STG}	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300 (1.8mm from case)	
	Mounting torque, 6-32 or M3 screw	10 lbf-in (1.1 Nm)	

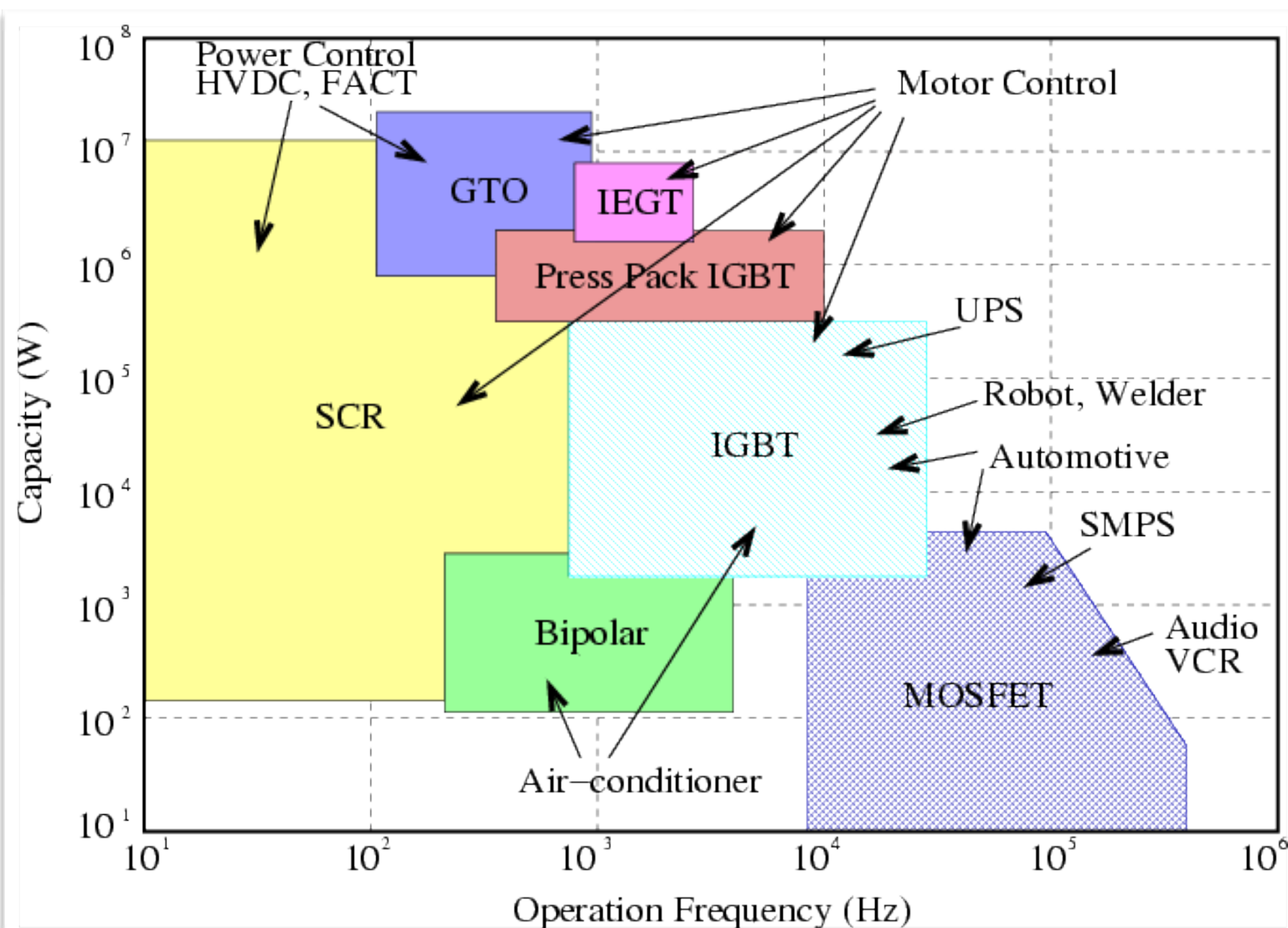
Thermal Resistance

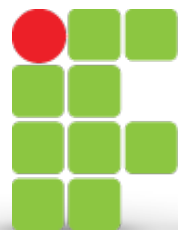
	Parameter	Typ.	Max.	Units
R_{JC}	Junction-to-Case	—	1.1	°C/W
R_{JCS}	Case-to-Sink, Flat, Greased Surface	0.24	—	
R_{JA}	Junction-to-Ambient	—	40	

MOSFET

Quando usar MOSFET:

1. Frequências altas (acima de 50 kHz);
2. Tensões muito baixas (< 500 V);
3. Potências baixas (< 1 kW).

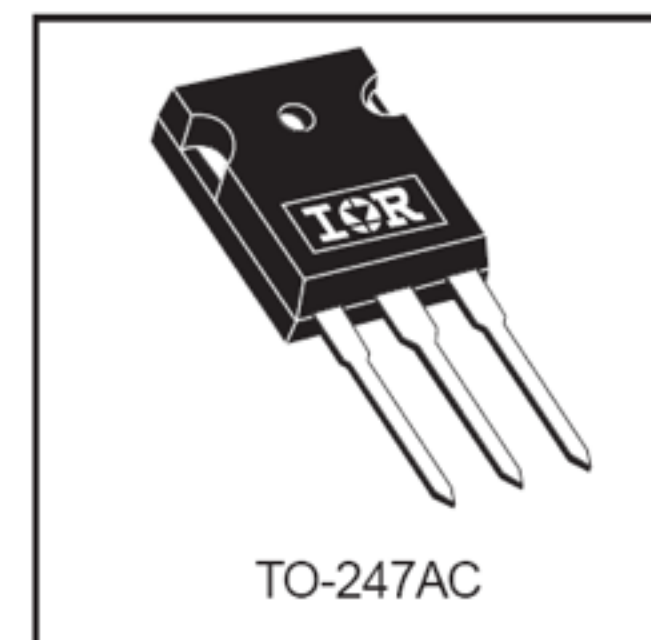
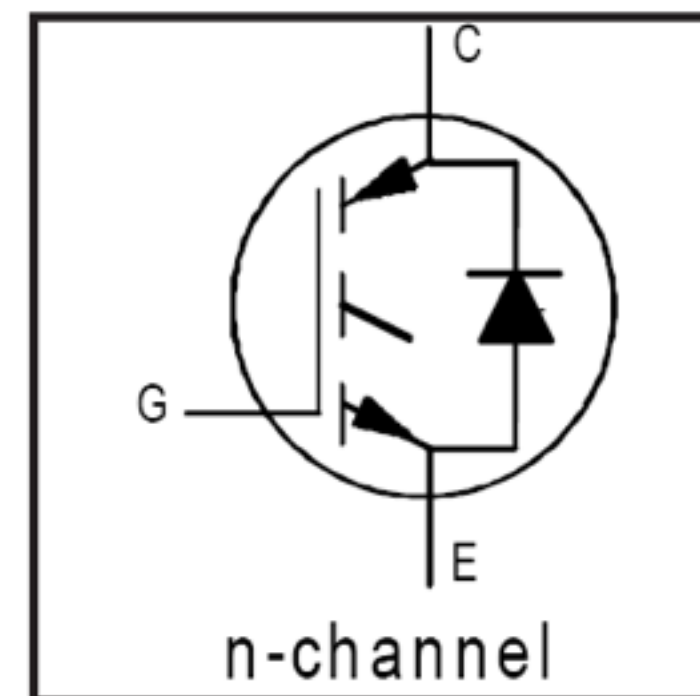
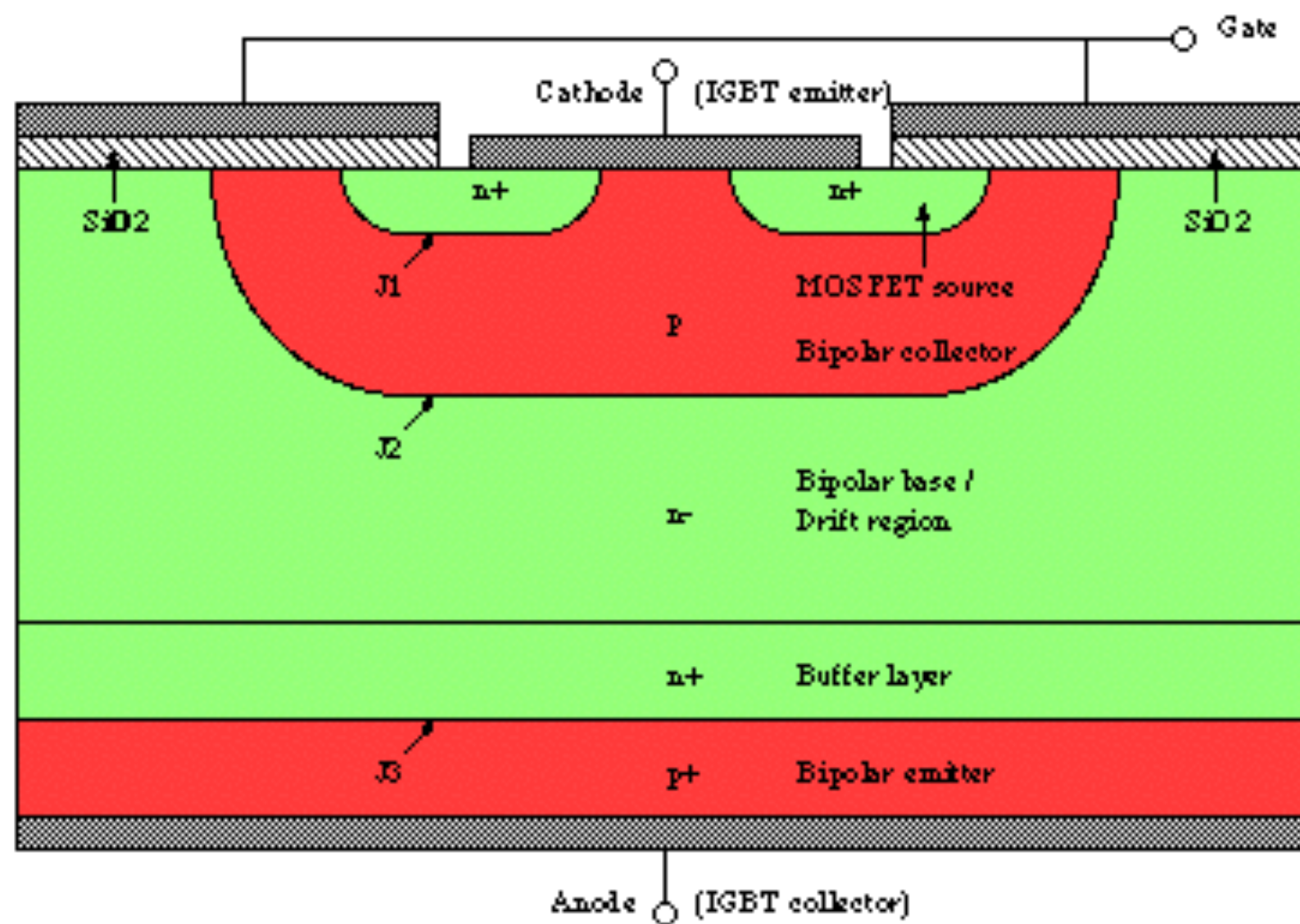




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IGBT

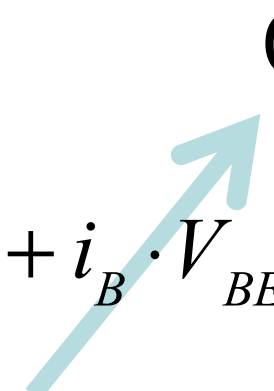
IGBT - Insulated Gate Bipolar Transistor



Características de BJT e MOSFET

Classificação das perdas:

1. Condução;

$$P_{cond} = \left(i_C \cdot V_{CEsat} + i_B \cdot V_{BEsat} \right) \cdot t_{on} \cdot f$$


2. Comutação:

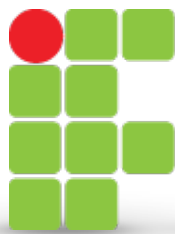
- Entrada em condução e bloqueio;

- Onde:

$$P_{com} = \frac{1}{2} (t_r + t_f) \cdot I \cdot E \cdot f$$

Detalhamento do cálculo de perdas





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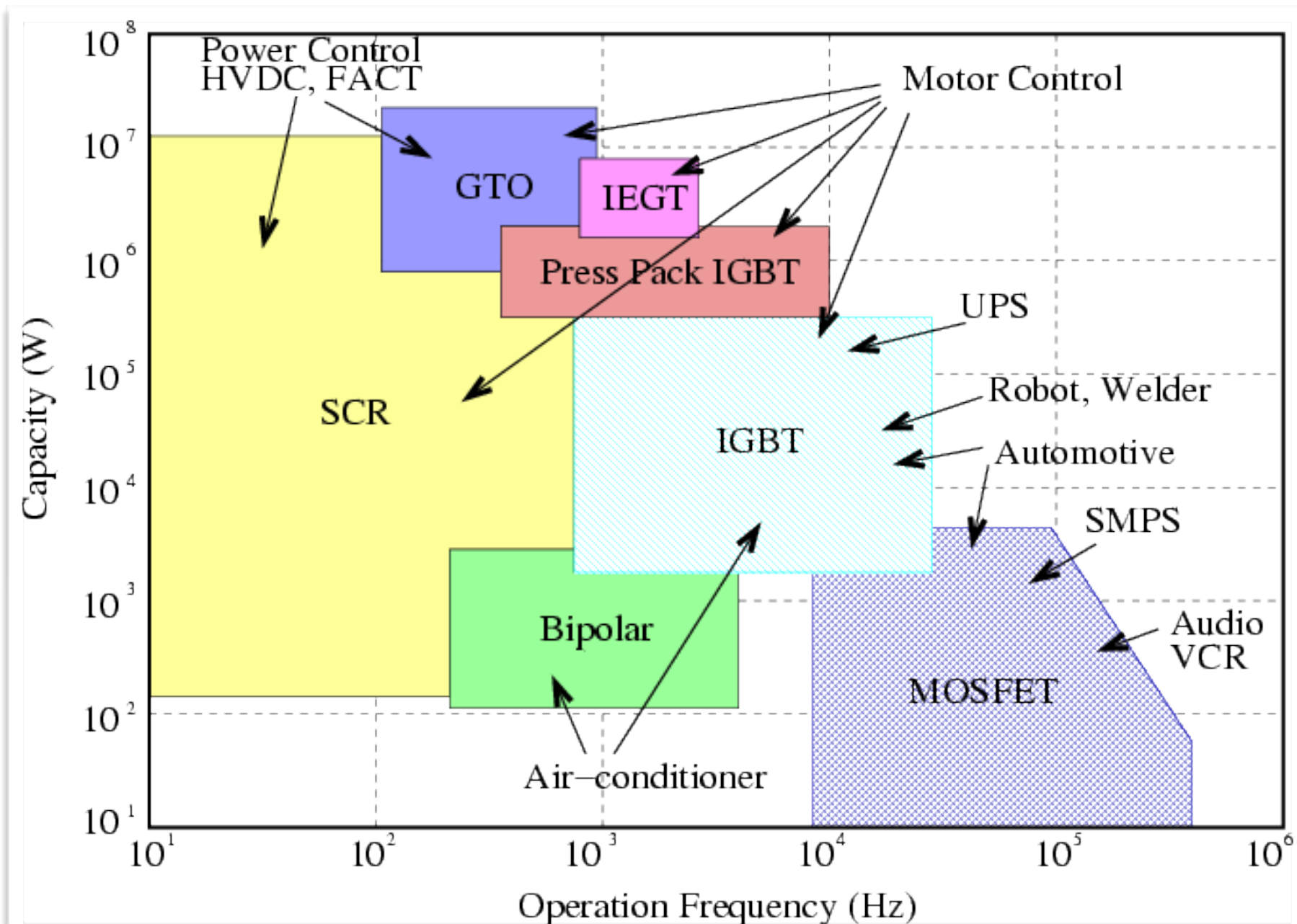
IGBT

Quando usar IGBT:

1. Frequências baixas (menor que 50 kHz);
2. Tensões altas (> 500 V);
3. Potências altas (> 1 kW).



Part	Family	Package	Circuit	Switching Speed
IRG4PH30K	IGBT Discretes	TO-247AC	Discrete	ULTRAFAST 4-20 kHz
IRG4PC20U	IGBT Discretes	TO-247AC	Discrete	ULTRAFAST 8-60 kHz
IRG4PC30S	IGBT Discretes	TO-247AC	Discrete	DC-1 kHz (STANDARD)
IRG4PC60U	IGBT Discretes	TO-247AC	Discrete	ULTRAFAST 8-60 kHz
IRG4BC30W	IGBT Discretes	TO-220AB	Discrete	WARP 60-150 kHz
IRG830B60K	IGBT Discretes	TO-220AB	Discrete	ULTRAFAST 10-30 kHz
IRG8B60K	IGBT Discretes	TO-220AB	Discrete	ULTRAFAST 10-30 kHz
IRG8B60K	IGBT Discretes	D2-Pak	Discrete	ULTRAFAST 10-30 kHz
IRG814C40U	IGBT Discretes	D2-Pak	Discrete	Low-Vceon
IRGP40S2	IGBT Discretes	TO-247AC	Discrete	Low-Vceon



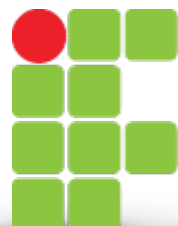
Quando usar IGBT:

1. Frequências baixas (menor que 50 kHz);
2. Tensões altas (> 500 V);
3. Potências altas (> 1 kW).



www.irf.com

Part	Family	Package	Circuit	Switching Speed	VCES (V)	VCE(ON) (V)	IC @ 25C (A)	IC @ 100C (A)	PD @25C (W)
▲ ▼	▲ ▼	▲ ▼	▲ ▼	▲ ▼	▲ ▼	▲ ▼	▲ ▼	▲ ▼	▲ ▼
IRG4PH30K	IGBT Discretes	TO-247AC	Discrete	ULTRAFast 4-20 kHz	1200	4.20	20	10	100
IRG4PC20U	IGBT Discretes	TO-247AC	Discrete	ULTRAFast 8-60 kHz	600	2.1	13	6.5	60
IRG4PC30S	IGBT Discretes	TO-247AC	Discrete	DC-1 kHz (STANDARD)	600	1.60	34	18	100
IRG4PC60U	IGBT Discretes	TO-247AC	Discrete	ULTRAFast 8-60 kHz	600	2.00	75	40	520
IRG4BC30W	IGBT Discretes	TO-220AB	Discrete	WARP 60-150 kHz	600	2.70	23	12	100
IRGB30B60K	IGBT Discretes	TO-220AB	Discrete	ULTRAFast 10-30 kHz	600	2.35	78	50	370
IRGB8B60K	IGBT Discretes	TO-220AB	Discrete	ULTRAFast 10-30 kHz	600	2.2	17	9.0	140
IRGS6B60K	IGBT Discretes	D2-Pak	Discrete	ULTRAFast 10-30 kHz	600	1.80	13	7	90
IRGS14C40L	IGBT Discretes	D2-Pak	Discrete	Low-Vceon	430	1.40	20	14	125
IRGP4050	IGBT Discretes	TO-247AC	Discrete	Low-Vceon	250	1.90	104	56	330

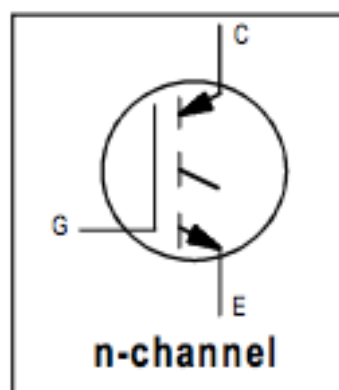
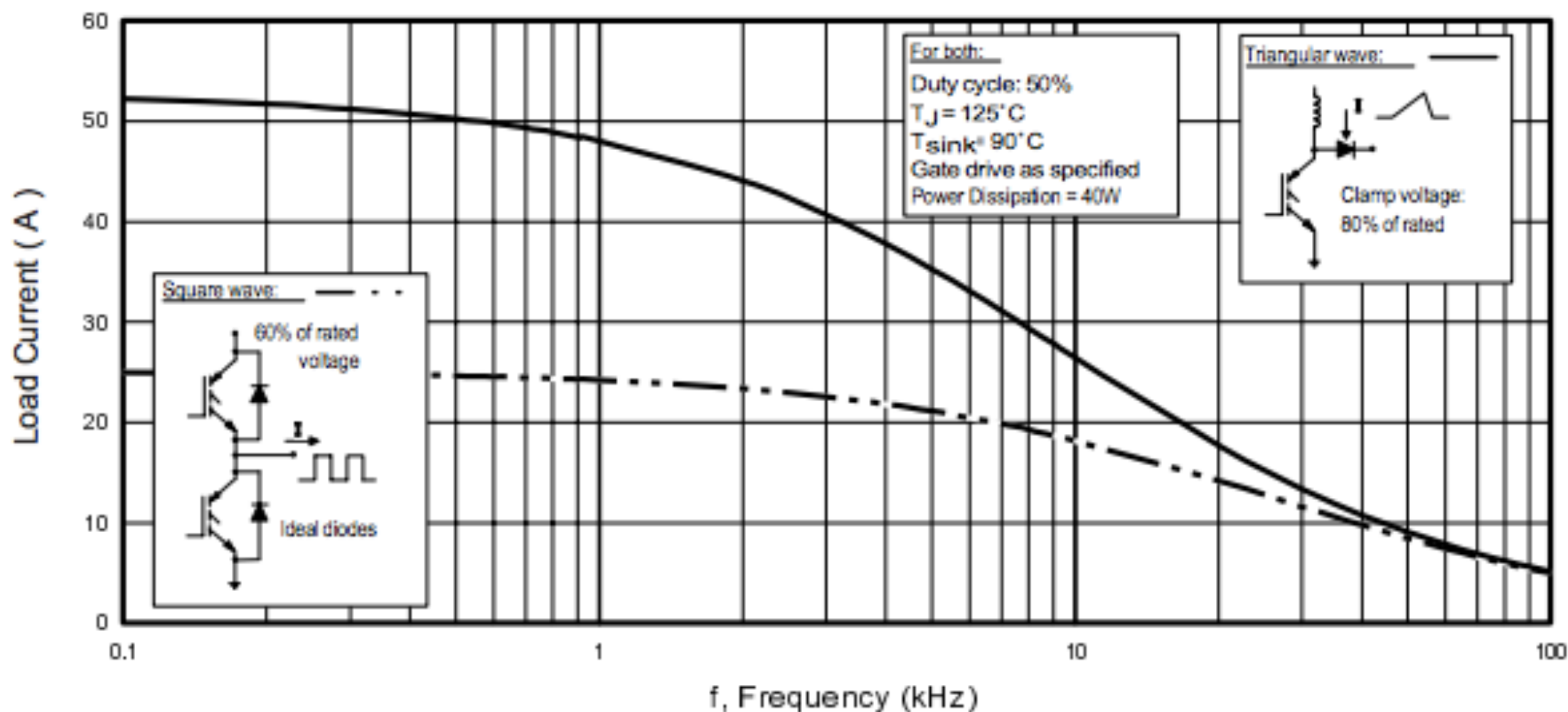


IGBT

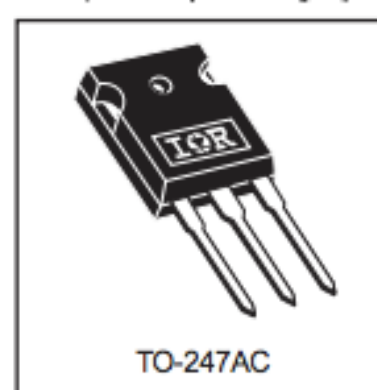
Package/Switching	Frequency	Voltage
<u>IGBT SINGLE / Soft</u>	<u>Ultrafast <30kHz</u>	<u>300V</u>
		<u>600V</u>
		<u>1200V</u>
<u>IGBT SINGLE / Hard</u>	<u>Standard <1kHz</u>	<u>600V</u>
		<u>1200V</u>
	<u>Fast 1-8kHz</u>	<u>600V</u>
	<u>Ultra Fast 8-30kHz</u>	<u>300V</u>
		<u>600V</u>
		<u>1200V</u>
	<u>Warp 30-150kHz</u>	<u>600V</u>
		<u>900V</u>
<u>IGBT Co-Pack / Soft</u>	<u>Ultrafast <30kHz</u>	<u>1200V</u>
<u>IGBT Co-Pack / Hard</u>	<u>Standard <1kHz</u>	<u>600V</u>
	<u>Fast 1-8kHz</u>	<u>600V</u>
	<u>Ultra Fast 8-30kHz</u>	<u>300V</u>
		<u>600V</u>
		<u>1200V</u>
	<u>Warp 30-150kHz</u>	<u>600V</u>
		<u>900V</u>

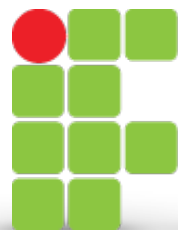
IGBT

IRG4PF50W



$V_{\text{CES}} = 900\text{V}$
 $V_{\text{CE(on) typ.}} = 2.25\text{V}$
@ $V_{\text{GE}} = 15\text{V}$, $I_{\text{C}} = 28\text{A}$





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IGBT

Encapsulamentos:



www.semikron.com



SEMITRANS™



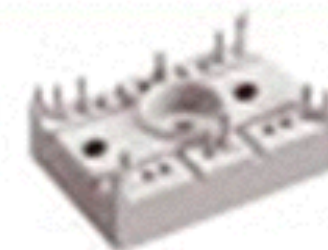
SEMiX®



SKiM™



MiniSKiiP®



SEMITOP®

Encapsulamentos:



D-PAK
TO-252AA



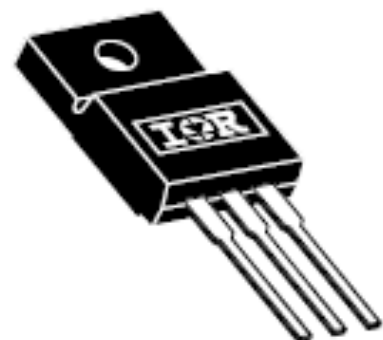
TO-220AB
IRGB6B60K



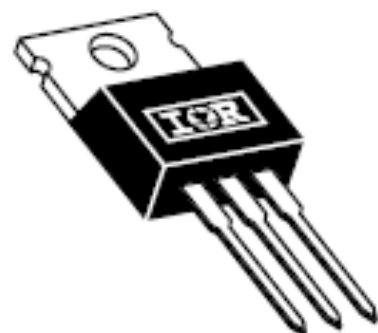
D²Pak
IRGS6B60K



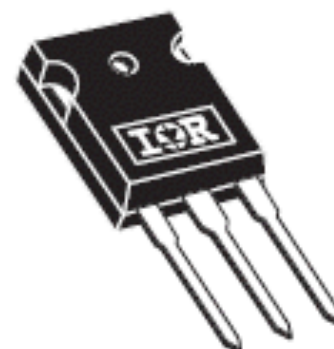
TO-262
IRGSL6B60K



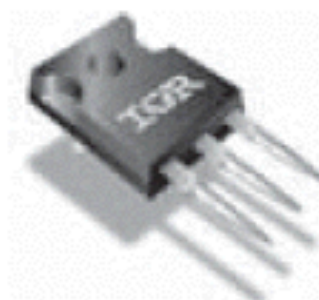
TO-220 FULLPAK



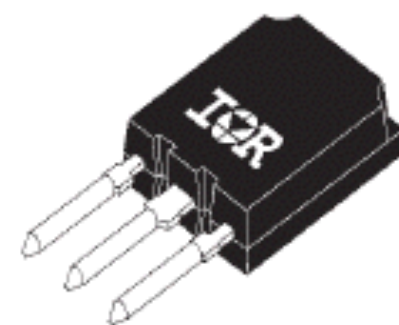
TO-220AB



TO-247AC



TO-247AC



SUPER - 247



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Dados de catalogo:

International IR Rectifier

INSULATED GATE BIPOLAR TRANSISTOR

PD - 94443

IRG4PC60U

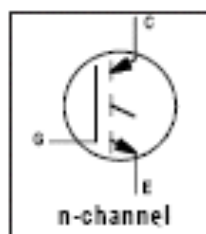
UltraFast Speed IGBT

Features

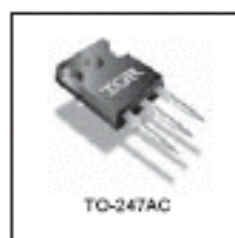
- UltraFast: Optimized for high operating frequencies up to 50 kHz in hard switching, >200 kHz in resonant mode.
- Generation 4 IGBT design provides tighter parameter distribution and higher efficiency.
- Industry standard TO-247AC package.

Benefits

- Generation 4 IGBT's offer highest efficiency available.
- IGBT's optimized for specified application conditions.
- Designed for best performance when used with IR Hexfred & IR Fred companion diodes.



$V_{CES} = 600V$
 $V_{CE(sat)} \text{ typ.} = 1.6V$
@ $V_{GE} = 15V, I_C = 40A$



Absolute Maximum Ratings

Parameter	Max.	Units
V_{CES}	600	V
$I_C @ T_C = 25^\circ C$	75	A
$I_C @ T_C = 100^\circ C$	40	
I_{CS}	300	
I_{CL}	300	
V_{GE}	± 20	V
E_{AS}	200	mJ
$P_D @ T_C = 25^\circ C$	520	W
$P_D @ T_C = 100^\circ C$	210	
T_J	-55 to +150	$^\circ C$
T_{stg}		
	300 (0.083 in. (1.6mm) from case)	
	10 lbf-in (1.1N-m)	

Thermal Resistance

Parameter	Typ.	Max.	Units
R_{JC}	----	0.24	$^\circ C/W$
R_{CS}	0.24	----	
R_{JA}	----	40	
Wt	8 (0.21)	----	

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04/28/02

International IR Rectifier

INSULATED GATE BIPOLAR TRANSISTOR WITH
ULTRAFAST SOFT RECOVERY DIODE

PD 9.1467D

IRG4PC40UD

UltraFast CoPack IGBT

Features

- UltraFast: Optimized for high operating frequencies 8-40 kHz in hard switching, >200 kHz in resonant mode.
- Generation 4 IGBT design provides tighter parameter distribution and higher efficiency than Generation 3.
- IGBT co-packaged with HEXFRED™ ultrafast, ultra-soft-recovery anti-parallel diodes for use in bridge configurations.
- Industry standard TO-247AC package.

Benefits

- Generation -4 IGBT's offer highest efficiencies available.
- IGBT's optimized for specific application conditions.
- HEXFRED diodes optimized for performance with IGBT's. Minimized recovery characteristics require less snubbing.
- Designed to be a "drop-in" replacement for equivalent industry-standard Generation 3 IR IGBT's.

Absolute Maximum Ratings

Parameter	Max.	Units
V_{CES}	600	V
$I_C @ T_C = 25^\circ C$	40	A
$I_C @ T_C = 100^\circ C$	20	
I_{CS}	160	
I_{CL}	160	
$I_F @ T_C = 100^\circ C$	15	A
I_{SM}	160	
V_{GE}	± 20	
$P_D @ T_C = 25^\circ C$	160	
$P_D @ T_C = 100^\circ C$	65	W
T_J	-55 to +150	
T_{stg}		$^\circ C$
	300 (0.083 in. (1.6mm) from case)	
	10 lbf-in (1.1 N-m)	

Thermal Resistance

Parameter	Min.	Typ.	Max.	Units
R_{JC}	----	----	0.77	$^\circ C/W$
R_{JC}	----	----	1.7	
R_{CS}	----	0.24	----	
R_{JA}	----	----	40	
Wt	----	8 (0.21)	----	g (oz)

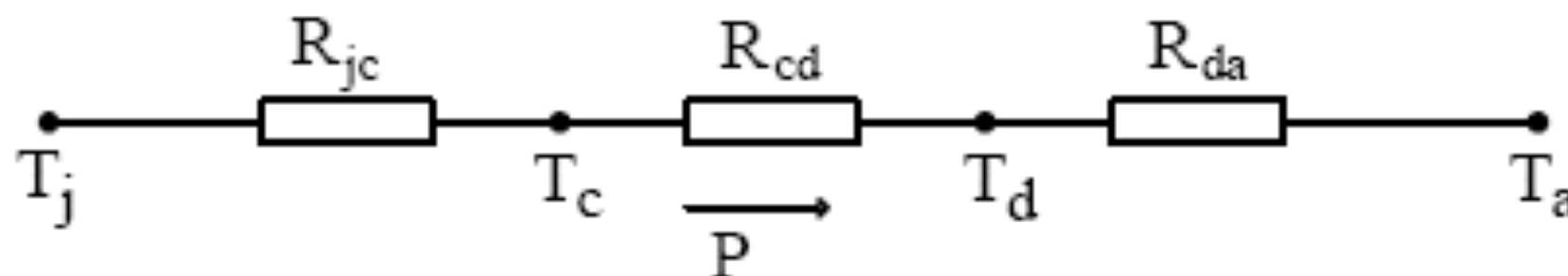
BJT x MOSFET x IGBT

	MOSFET	IGBT	BJT
Tipo de comando	Tensão	Tensão	Corrente
Potência do comando	Mínima	Mínima	Grande
Complexidade do comando	Simples	Simples	Média
Densidade de corrente	Elevada em baixas tensões e Baixa em altas tensões	Muito elevada	Média
Perdas de comutação	Muito baixa	Baixa para Média	Média para Alta

Cálculo Térmico

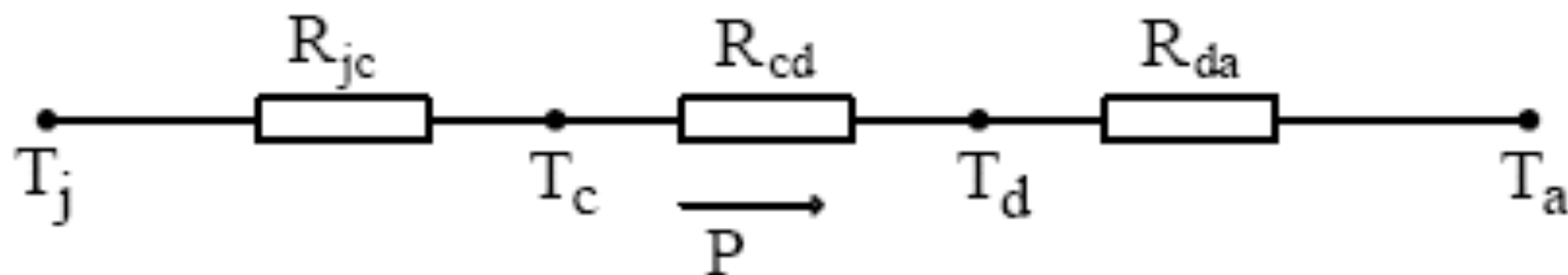
Cálculo térmico:

- Objetivo de verificar a necessidade de uso de dissipador de calor ou não.
- Modelo térmico:



- T_j = temperatura na junção ($^{\circ}\text{C}$);
- T_c = temperatura na cápsula ($^{\circ}\text{C}$);
- T_d = temperatura no dissipador ($^{\circ}\text{C}$);
- T_a = temperatura ambiente ($^{\circ}\text{C}$);
- R_{jc} = resistência térmica entre junção e cápsula ($^{\circ}\text{C}/\text{W}$);
- R_{cd} = resistência térmica entre cápsula e dissipador ($^{\circ}\text{C}/\text{W}$);
- R_{da} = resistência térmica entre dissipador e ambiente ($^{\circ}\text{C}/\text{W}$);
- P = potência dissipada no componente (W).

Cálculo Térmico



$$R_{ja} = R_{jc} + R_{cd} + R_{da}$$

$$T_j - T_a = R_{ja} \cdot P \quad \Rightarrow \quad R_{ja} = \frac{T_j - T_a}{P}$$

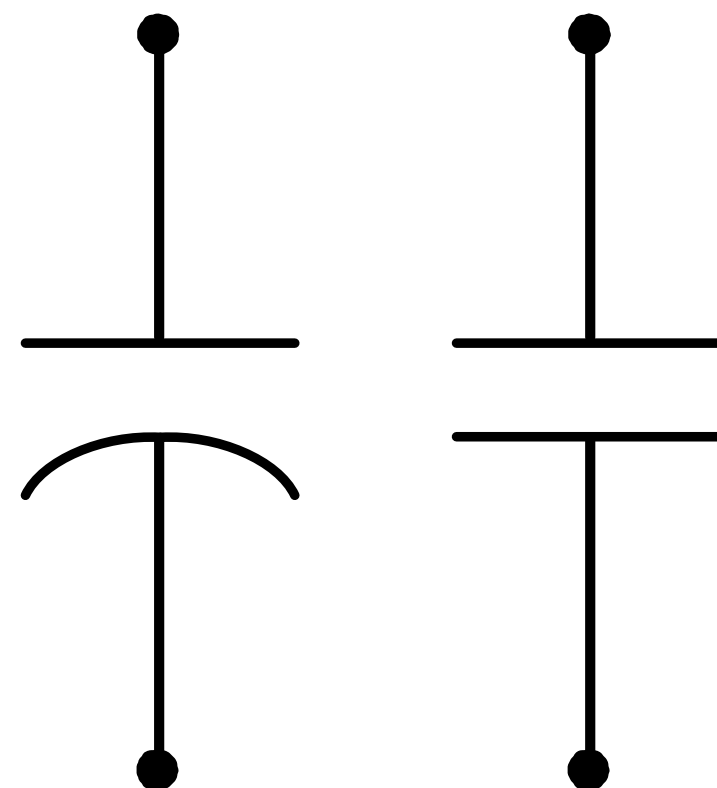
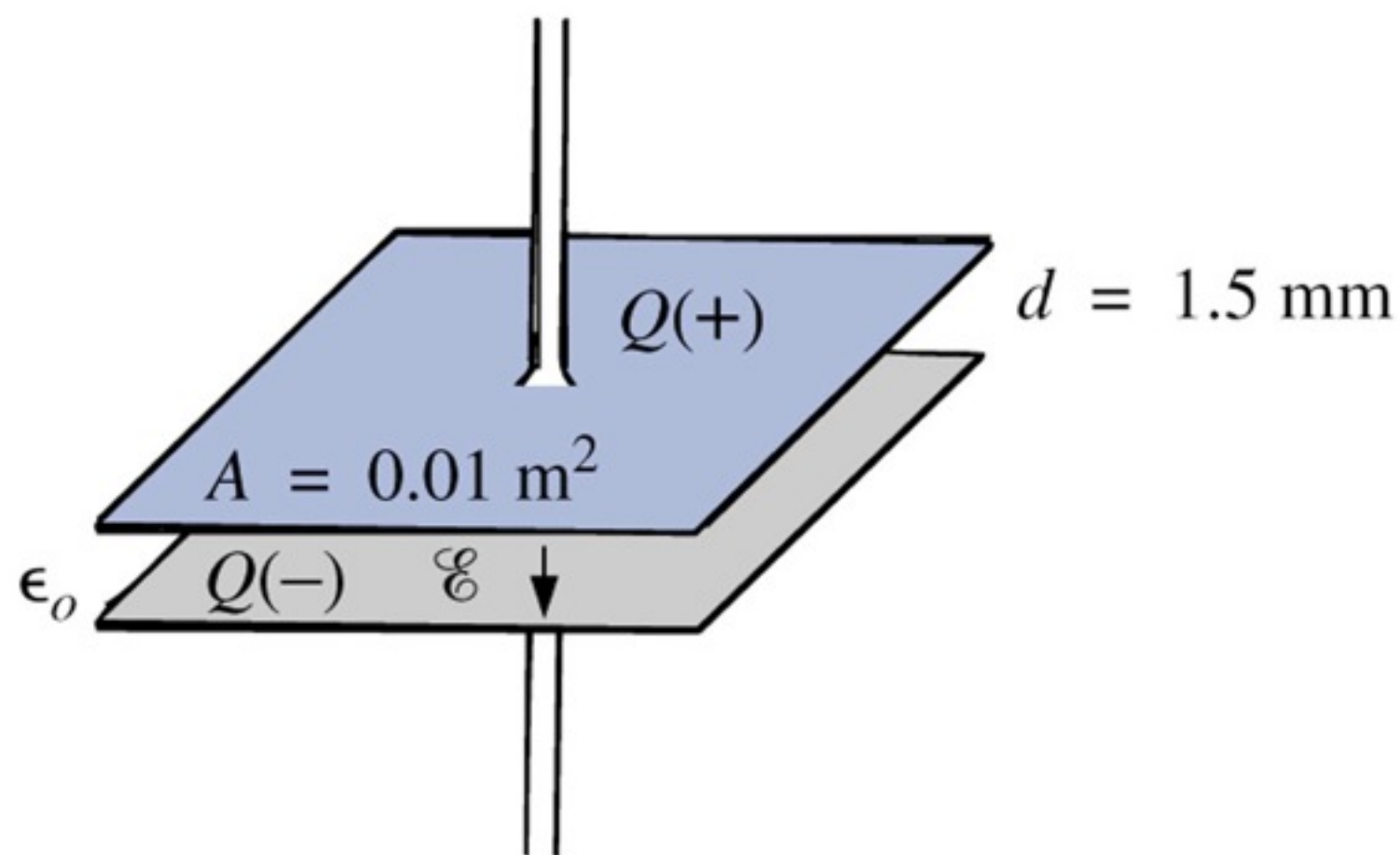
$$R_{da} = R_{ja} - R_{jc} - R_{cd}$$



Capacitores

A capacitância depende de:

- Dielétrico (permissividade);
- Área das placas;
- Distância entre as placas.



Capacitores



Modelo equivalente do capacitor

Onde:

- C = Capacitância;
- RSE = Resistência série equivalente;
- LSE = Indutância série equivalente.

Perdas devido à RSE :

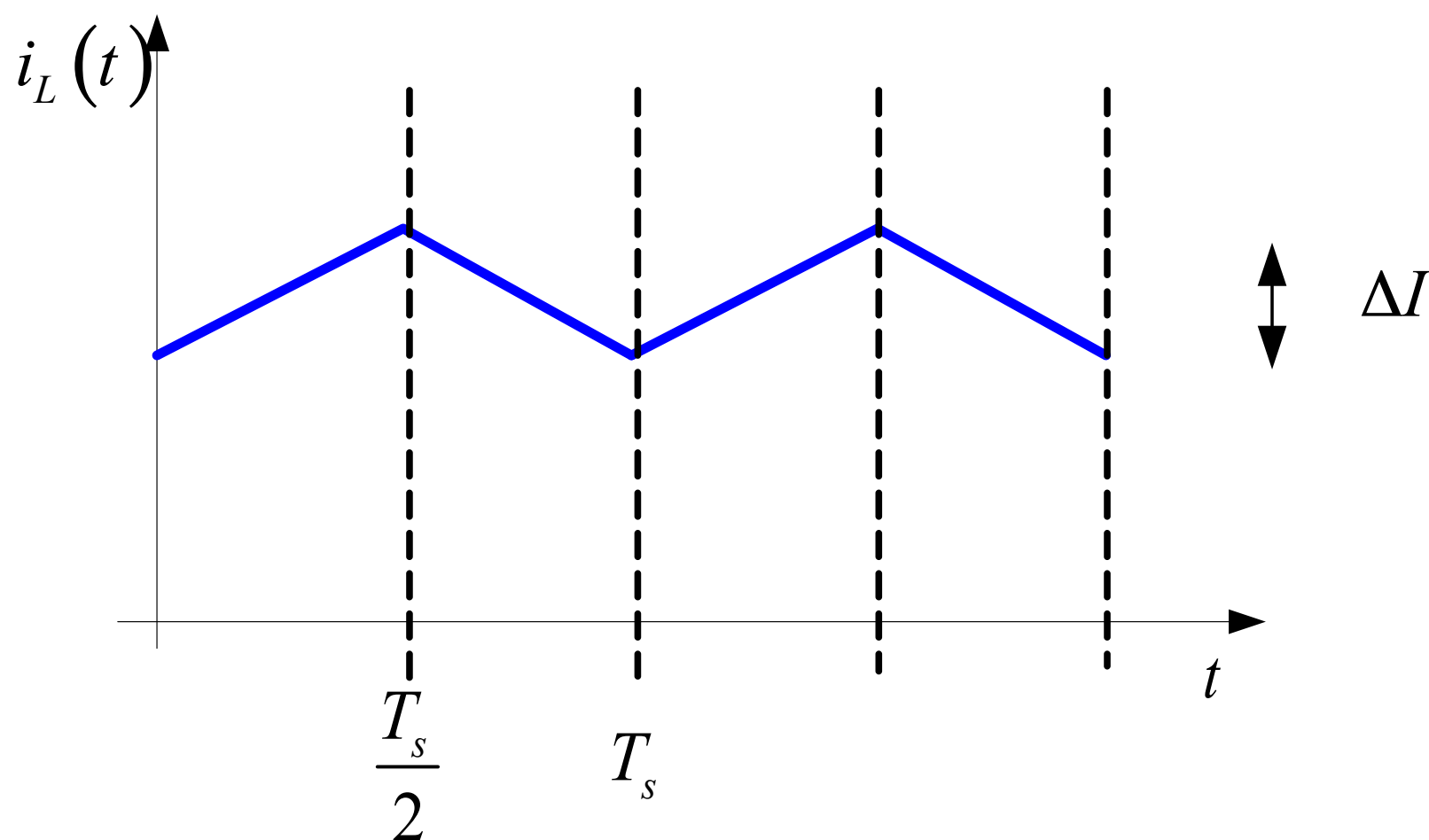
$$P = RSE \cdot I_{ef}^2$$

Capacitores



Ondulação da tensão:

$$\Delta V = RSE \cdot \Delta I$$

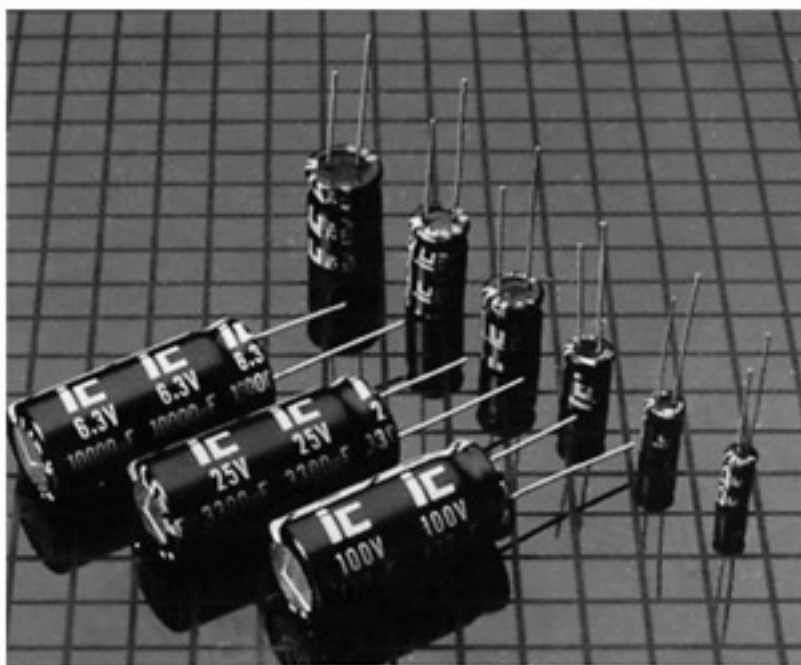


Capacitores

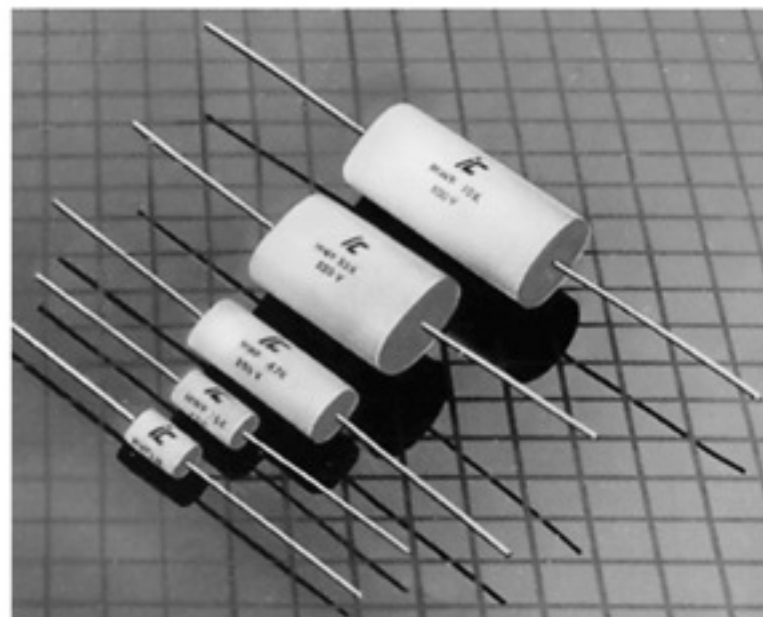
Tecnologias de capacitores:

- Filtro do retificador de entrada - São empregados capacitores eletrolíticos de alta tensão e grandes capacitâncias;
- Filtro de saída dos conversores - Empregam-se capacitores eletrolíticos alumínio com baixa RSE;
- Circuitos de grampeamento (snubber) - São utilizados capacitores com dielétricos de polipropileno para regime intermitente de funcionamento.

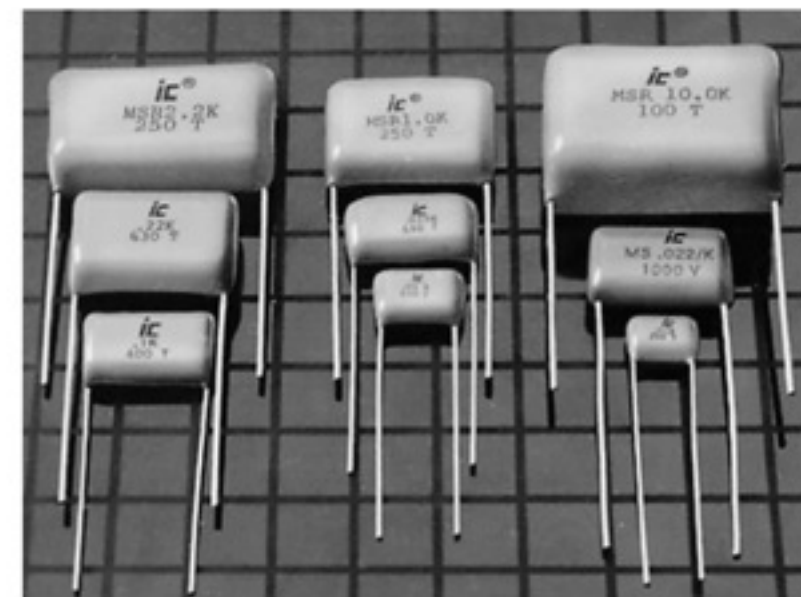
Capacitores



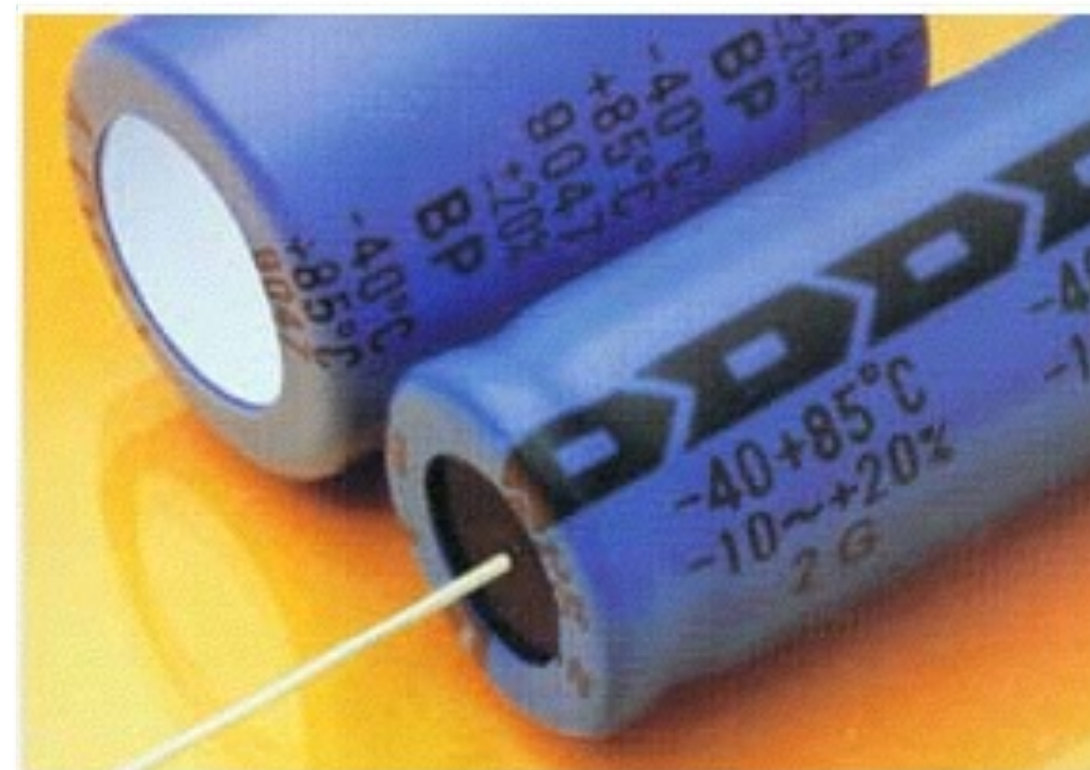
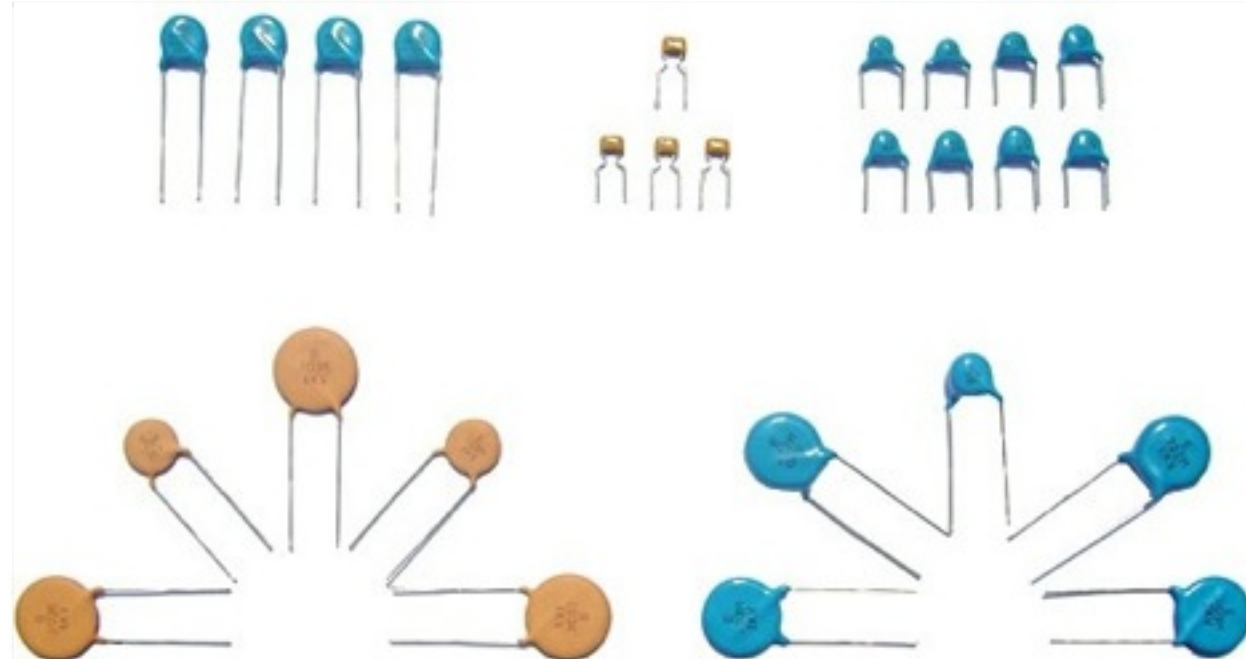
(a)

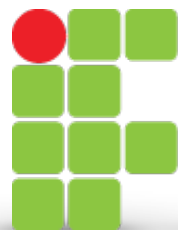


(a)



(b)





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Fusíveis

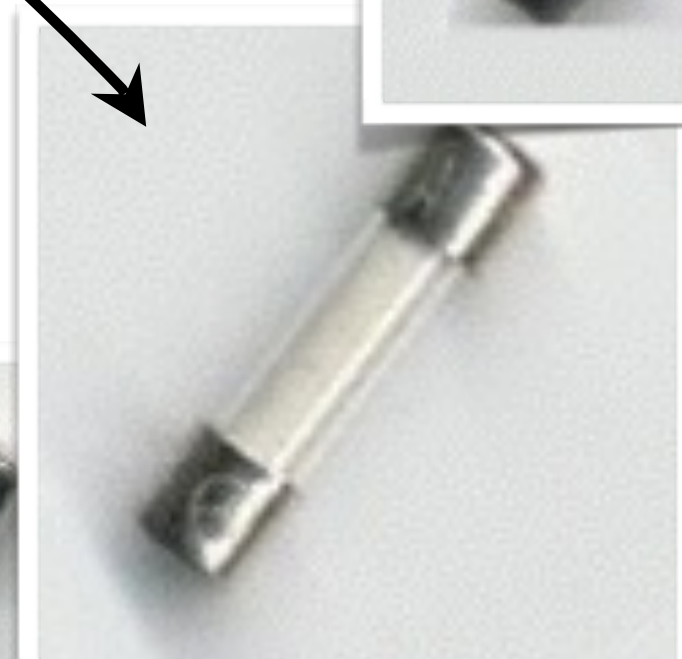
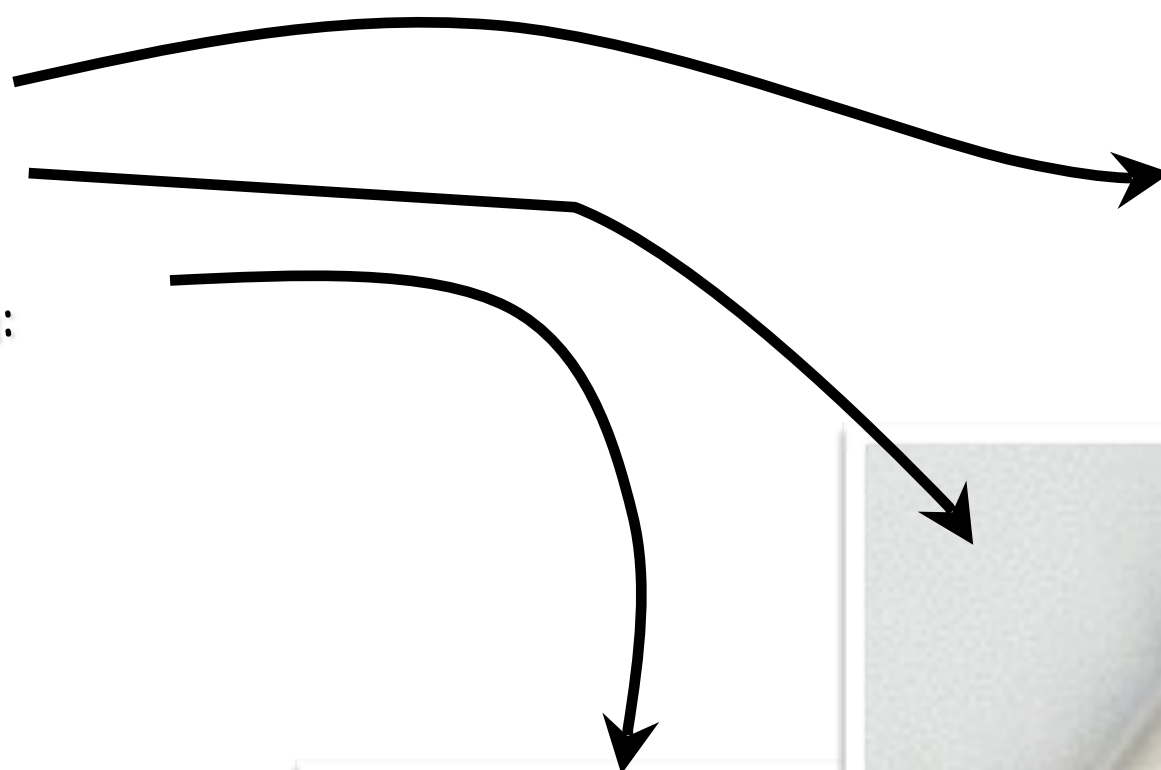
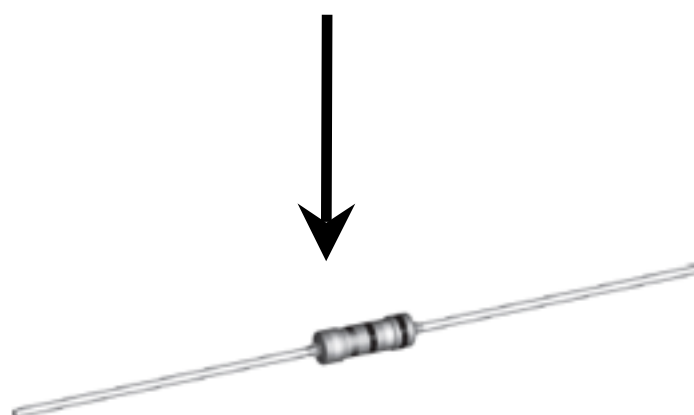
Fusíveis de ação lenta:

- Vidro;
- Areia;
- Cerâmica.

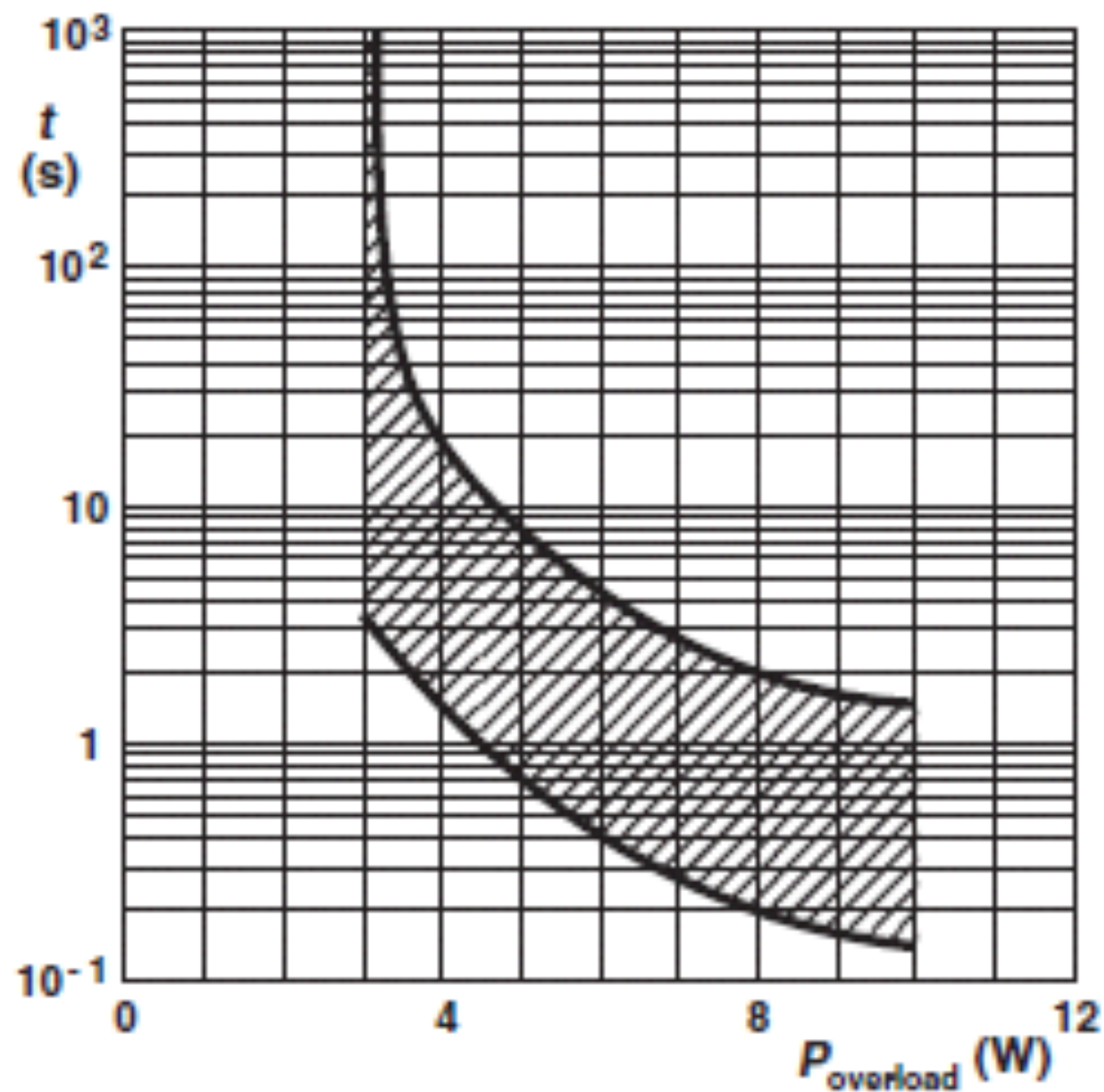
Fusíveis de ação rápida:

- Vidro;
- Areia;
- Cerâmica.

Resistores fusíveis.



Fusíveis

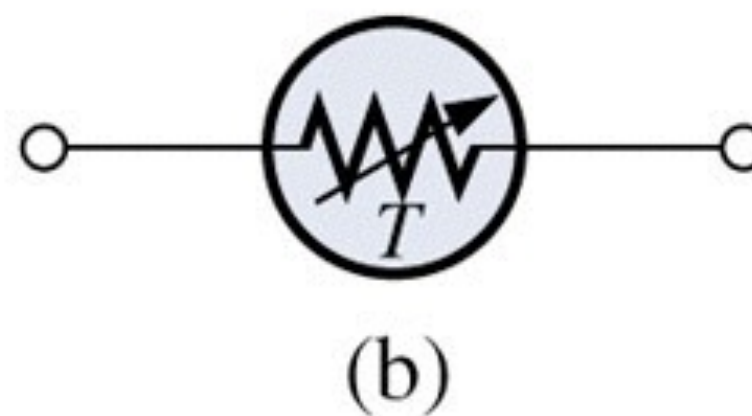
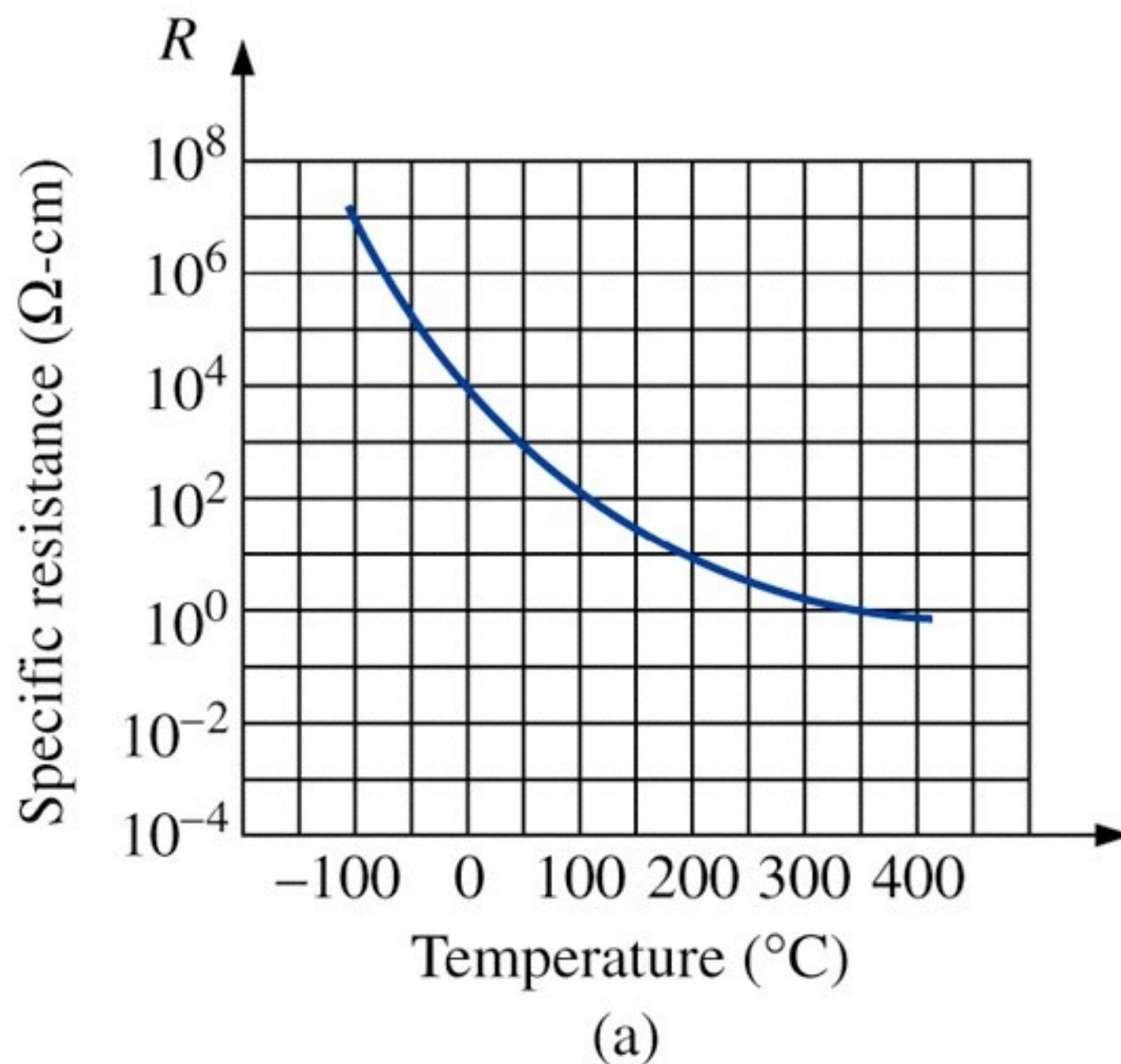


NR25 - $1 \Omega < R < 15 \Omega$

Termistores

Termistor:

- Resistor cuja resistência é sensível à variação da temperatura.



Próxima Aula

Conversores ca-cc:

- Retificadores e filtro capacitivo.

